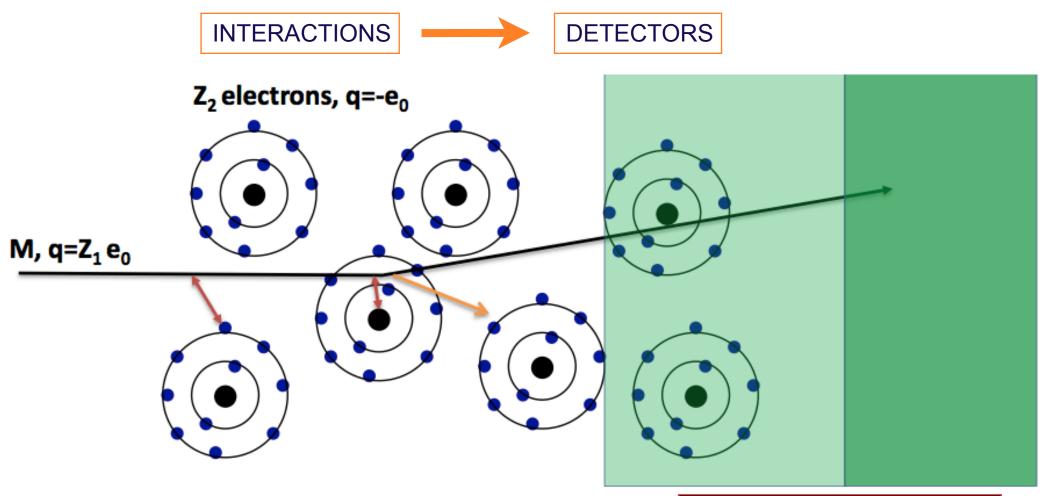
# INSTRUMENTATION & DETECTORS for HIGH ENERGY PHYSICS



#### ELECTROMAGNETIC INTERACTIONS OF PARTICLES WITH MATTER



Interaction with the atomic electrons.

The incoming particle loses energy and the atoms are **exited** or **ionised**.

Interaction with the atomic nucleus.

The incoming particle is deflected causing **multiple scattering** of the particle in the material.

During this scattering a

Bremsstrahlung photon can
be emitted

In case the particle's velocity is larger than the velocity of light in the medium, the resulting EM shockwave manifests itself as **Cherenkov radiation**. When the particle crosses the boundary between two media, there is a probability of 1% to produce an Xray photon called **Transition radiation**.

#### INTERACTIONS OF PARTICLES WITH MATTER

#### **IONISATION AND EXCITATION**

Charged particles traversing material and exciting and ionising atoms.

The average energy loss of the incoming particle by the process is to a good approximation described by the Bethe-Block formula.

#### **CHERENKOV RADIATION**

If a particle propagates in a material with velocity > speed of light in this material, C radiation is emitted at a characteristic angle that depends on the particle velocity and the refractive index of the medium

#### TRANSITION RADIATION

If a charged particle is crossing the boundary between two materials of different dielectric permittivity, there is a certain probability for emission of an X-ray photon.

#### **MULTIPLE SCATTERING AND BREMSSTRAHLUNG**

Incoming particles are scattering off the atomic nuclei which are partially shielded by the atomic electrons.

This scattering imposes a lower level on the momentum resolution of the spectrometer, when measuring the particle momentum by deflection of the particle trajectory in the magnetic field.

The deflection of the particle on the nucleus results in an acceleration that causes the emission of Bremsstrahlung photons.

The photons in turn produce e+e- pairs in the vicinity of the nucleus, which causes the EM cascade.

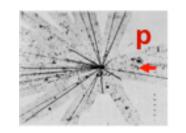
This effect depends on m<sup>-2</sup>: only relevant for electrons.

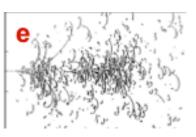
#### **HADRONIC INTERACTION**

Incoming hadrons on a material will interact with the nucleus and create a shower composed of hadrons, electrons, photon. A fraction of the energy is *lost* in the form of binding energy or neutrinos.



1. Particles interact with matter depends on particle and material



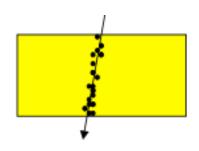


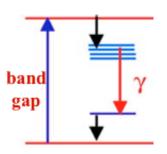
2. Energy loss transfer to detectable signal depends on the material

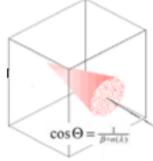
Detecting emitted light

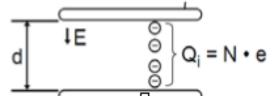
Detecting ionisation current

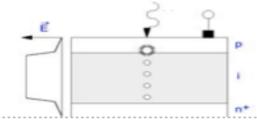
3. Signal collection depends on signal and type of detection











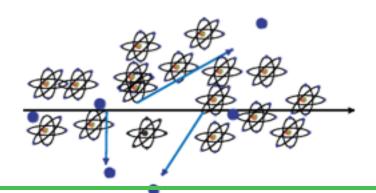
4. BUILD a SYSTEM

depends on physics, experimental conditions,....



#### CREATION of the SIGNAL

Charged particles traversing matter leave excited atoms, electron-ion pairs (gas, liquid) or electrons-holes pairs (solids) behind.



#### **Excitation**

The photons emitted by the excited atoms in transparent materials can be detected with photon detectors like photomultipliers or semiconductor photon detectors.

#### **Ionisation**

By applying an electric field in the detector volume, the ionisation electrons and ions are moving, which induces signals on metal electrodes. These signals are then readout by appropriate readout electronics.

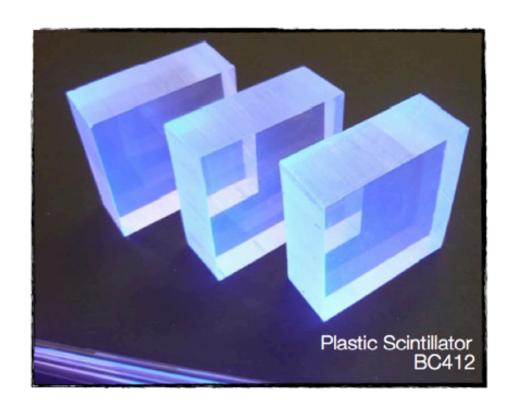
#### **SCINTILLATORS - GENERALITIES**

### Principle:

dE/dx converted into visible light Detection via photosensor [e.g. photomultiplier, human eye ...]

#### Main Features:

Sensitivity to energy
Fast time response
Pulse shape discrimination



### Requirements

High efficiency for conversion of excitation energy to fluorescent radiation Transparency to its fluorescent radiation to allow transmission of light Emission of light in a spectral range detectable for photosensors Short decay time to allow fast response

# DETECTORS BASED on REGISTRATION of EXCITED ATOMS: SCINTILLATORS

# Emission of photons by excited atoms: typically UV to visible light

Observed in Noble Gases (an even in liquid)

#### **Inorganic crystals**

Substance with largest light yield. Used for precision measurement of energetic photons

Polyzyclic Hydrocarbons such as Naphtalen, Anthrazen, organic scintillators:

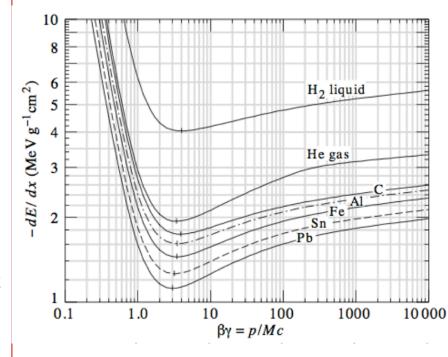
Large scale industrial production: mechanically and chemically quite robust.

Characteristic are one or two decay times of light emission

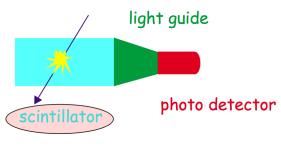
#### Typical light yield of scintillators

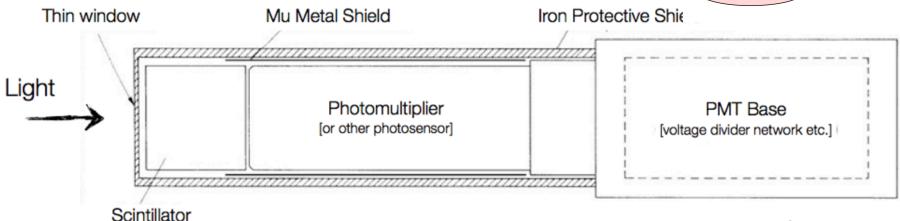
Energy (visible photons): few % of the total energy loss.

1 cm of plastic scintillator, p=1 g.cm<sup>-3</sup>, dE/dx~1.5 MeV, ~15 keV in photons i.e. 15000 photons produced.



# SCINTILLATORS: BASIC SETUPs





## Scintillator Types:

Organic Scintillators

Inorganic Crystals

Gases

#### **Photosensors**

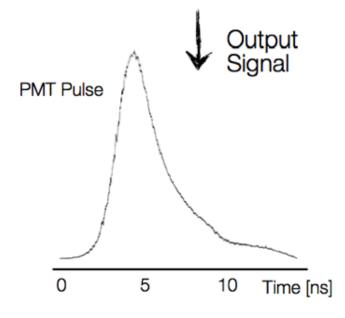
Photomultipliers

Micro-Channel Plates

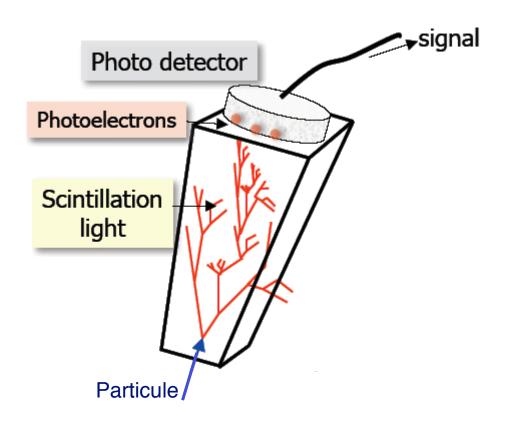
Hybrid Photo Diodes

Visible Light Photon Counter

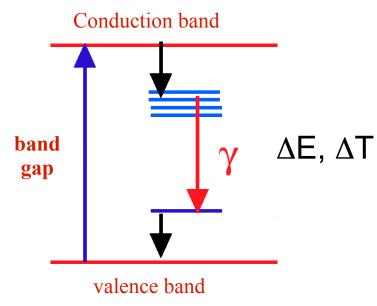
Silicon Photomultipliers

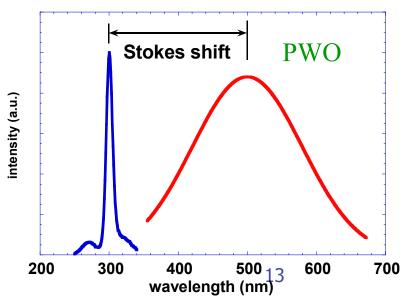


## CMS CRISTALs



Fast light emission: ~80% in 25 ns Peak emission ~500 nm (visible region) Radiation resistant to very high doses





# CMS BARREL ECAL



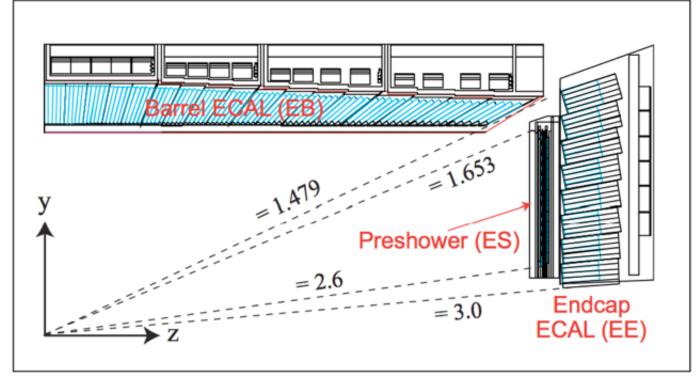
Scintillator : PBWO<sub>4</sub> [Lead Tungsten]

Photosensor: APDs [Avalanche Photodiodes]

Number of crystals: ~ 70000 Light output: 4.5 photons/MeV



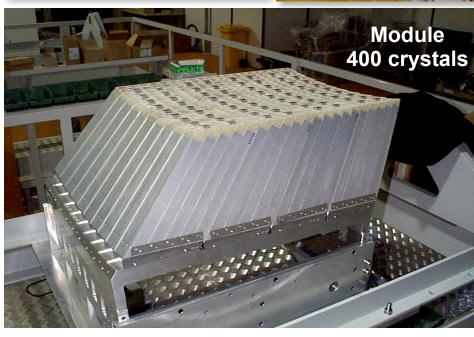




# CMS ECAL CONSTRUCTION







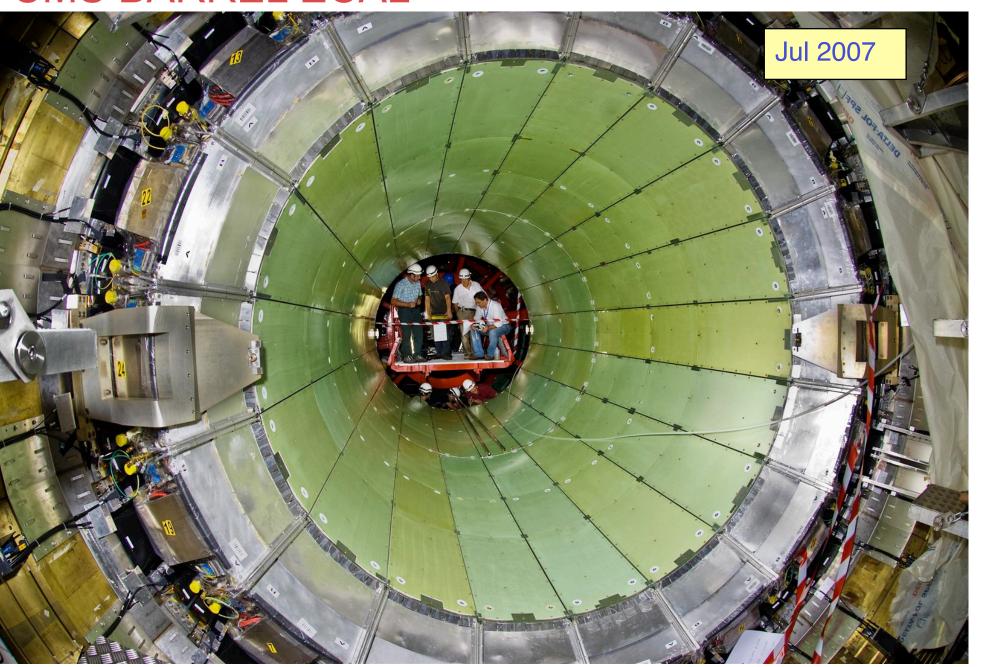






Total 36 Supermodules

# CMS BARREL ECAL



# ORGANIC SCINTILLATORS

Excited vibrational modes of molecules de-excite by emission of UV light

This UV light is then transformed into visible light by wave length shifters that are added to the materials

#### Mono crystals

Naphtalen (C<sub>10</sub>H<sub>8</sub>)

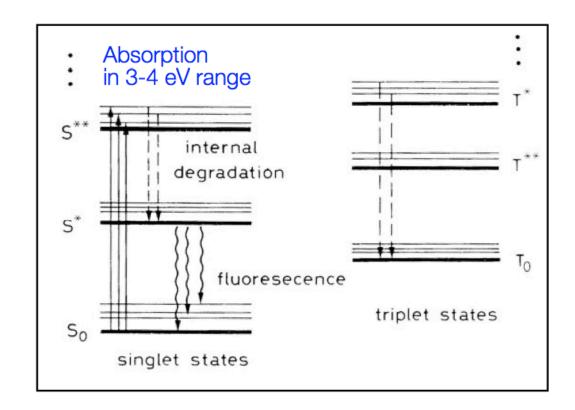
Anthrazen (C<sub>10</sub>H<sub>10</sub>)

..

#### Liquid and plastic scintillators

organic substance (polystyrol) + scintillating molecules (~1%)

in addition: secondary fluor compunds as wave length shifters



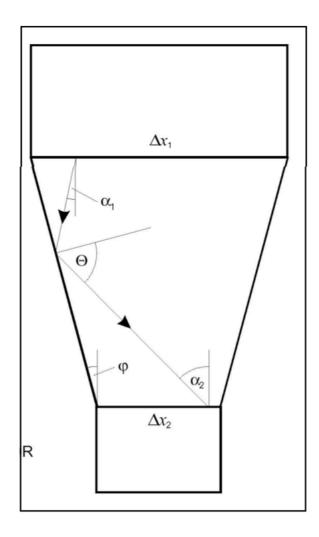
# Comparison organic vs inorganic scintillators

t: 1-3	w Light Yield	3ns	Large Light Yield	Slow	Slow: few 100n	
Decay* time (ns)	Attenuation <sup>e</sup> Light <sup>e</sup> $\lambda_{max}^{*}$ length Riscouput (nm) (cm) (ns)	Pulse FWHM (ns)	lig	lative \( \lambda_{\text{nat}} \)  to t emission (put (nm)	Decay n time (ns)	Density (g/cm³)
2.2-2.5 1.7-2.0 3.0 2.9-3.3	58-70 423 250 0. 68 406 120 0. 59 406 120 1 60 434 400 1.	2.0 2.2-2.5	Inorganic crystals NaI(Tl) 23 CsI(Tl) 25 Bi <sub>4</sub> Ge <sub>3</sub> O <sub>12</sub> (BGO) 23		230 900 300	3.67 4.51 7.13
1.3-1.7 4.0 1.6-1.9 2.1 1.4-1.5	40-55 375 8 0. 42-50 434 350-400 ~1. 60-68 408 125 0. 64 425 300 0. 58-67 391 100-140 0.	1.7 1.2-1.6 5.3 1.9 2.4-2.7 3.0-3.3	Organic crystals Anthracene 10 Trans-stilbene 7. Naphthalene 3. p.p'-Quarterphenyl 9.	5 384 2 330-34	22 4.5 76-96 7.5	1.25 1.16 1.03 1.20
1.8 2.1 1.5 3.3 2.4	68 408 — 0. 64 425 — 0. 64 391 — 0. 60 434 400 — 65 423 250 —	2.2 ~2.5 1.3 3.3 2.7	Primary activators 2,5-Diphenyl-oxazole (PPO) 2-Phenyl-5-(4-biphenylyl)- 1,3,4-oxadiazole (PBD) 90	360-41		
	60 434 400	3.3	3.3 3.3 2.4 2.7	1.5 1.3 2-Phenyl-5-(4-biphenylyl)- 3.3 3.3 1,3,4-oxadiazole (PBD) 96 2.4 2.7 4,4"-Bis(2-butyloctyloxy)-p-	1.5 1.3 2-Phenyl-5-(4-biphenylyl)- 3.3 3.3 1,3,4-oxadiazole (PBD) 96 360-5 2.4 2.7 4,4"-Bis(2-butyloctyloxy)-p-	1.5 1.3 2-Phenyl-5-(4-biphenylyl)- 3.3 3.3 1,3,4-oxadiazole (PBD) 96 360-5 2.4 2.7 4,4"-Bis(2-butyloctyloxy)-p-

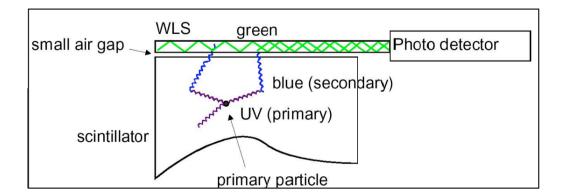
LHC bunchcrossing 25ns

LEP bunchcrossing  $25\mu s$ 

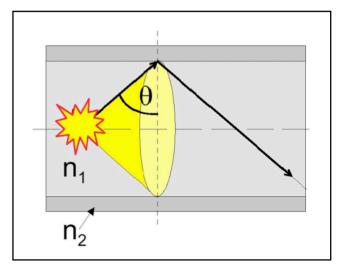
# LIGHT COLLECTION



Plexiglass light guide



Wave length shifter bars

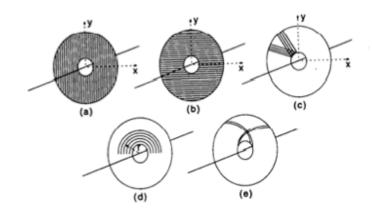


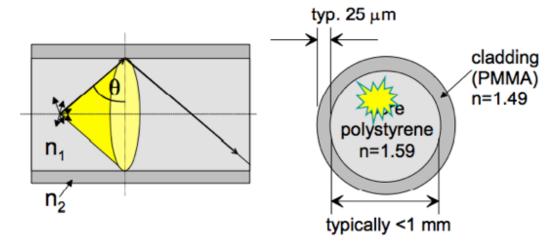
Total reflection in optical fibers

# FIBER TRACKING

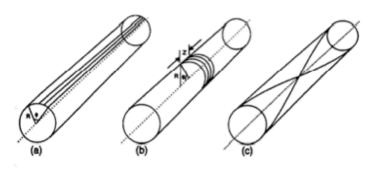
#### LIGHT TRANSPORT BY TOTAL INTERNAL REFLECTIONS

# Planar geometries (end cap)





# Circular geometries (barrel)



(R.C. Ruchti, Annu. Rev. Nucl. Sci. 1996, 46,281)

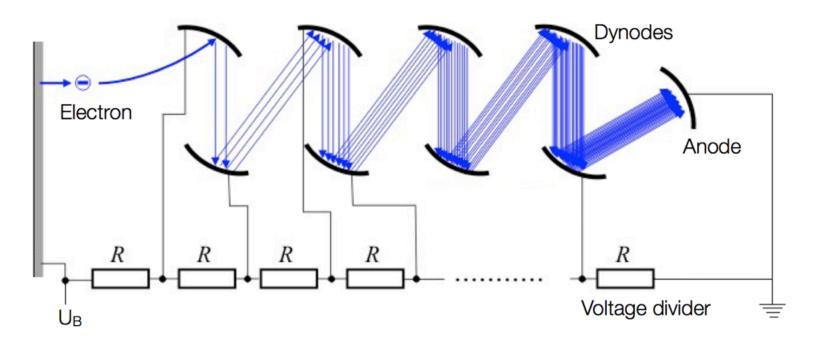
High geometrical flexibility

Fine granularity

Low mass

Fast response (ns)

# Photo multipliers



#### Multiplication process:

Electrons accelerated toward dynode Further electrons produced → avalanche

Secondary emission coefficient:

 $\delta = \#(e^- \text{produced})/\#(e^- \text{incoming})$ 

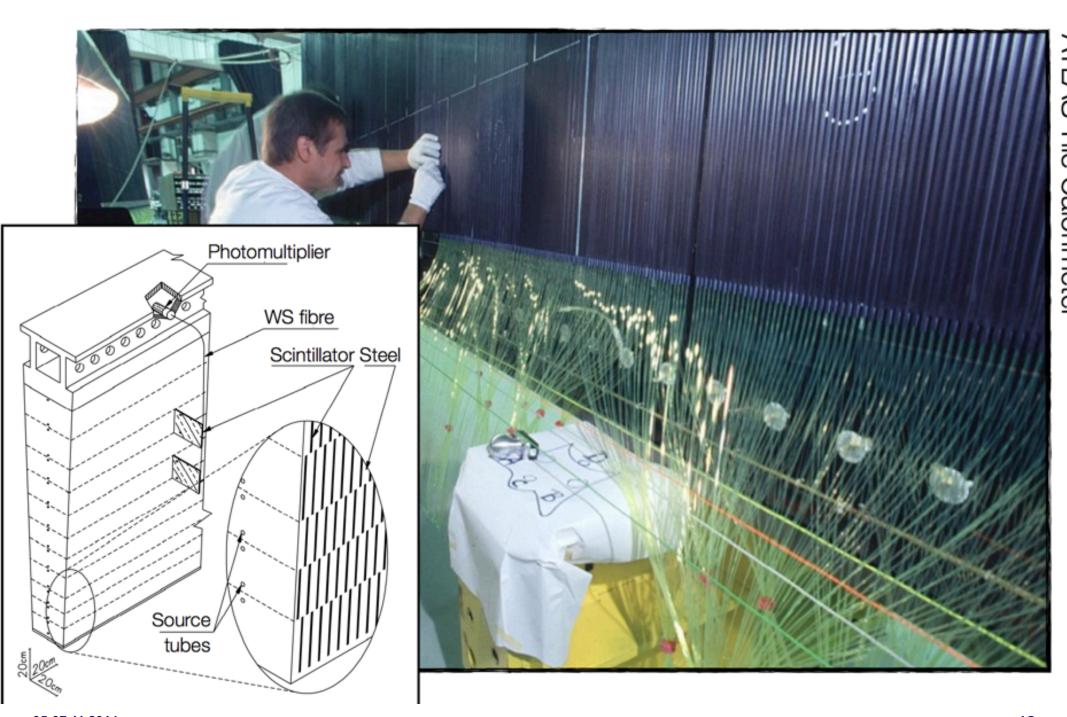
Typical: 
$$\delta = 2 - 10$$
  
 $n = 8 - 15$   $\rightarrow$   $G = \delta^n = 10^6 - 10^8$ 

Gain fluctuation: 
$$\delta = kU_D$$
;  $G = a_0(kU_D)^n$   
 $dG/G = ndU_D/U_D = ndU_B/U_B$ 



PMT Collection

# ATLAS TILES CALORIMETER



# LIGHT COLLECTION: EXAMPLEs from CMS

#### APD: ECAL barrel

Photo-eletrons from THIN 6µm p-layer induce avalanche in p-n junction

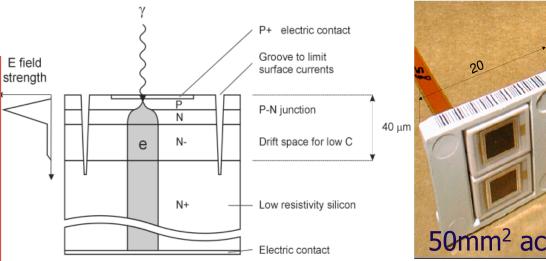
Electrons from ionising particles traversing the bulk are NOT amplified

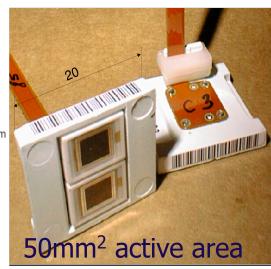
Vacuum Phototriodes: ECAL **Endcaps** 

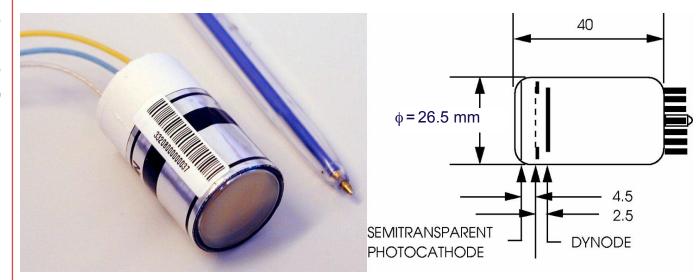
> Single stage PM tube with fine metal grid anode (insensitive to axial magnetic fields)

Favourable for EC-ECAL

Q.E. ~20% at 420nm







# SILICIUM PM's

#### Principle:

Pixelized photo diodes operated in Geiger Mode

Single pixel works as a binary device

Energy = #photons seen by summing over all pixels

#### Features:

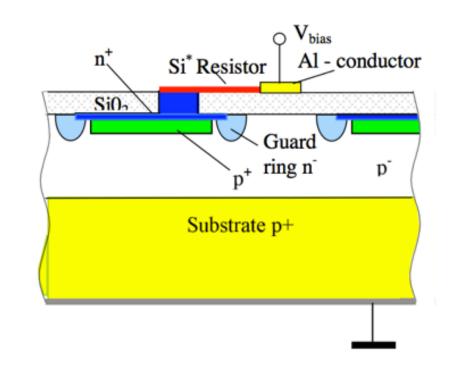
Granularity: 10<sup>3</sup> pixels/mm<sup>2</sup>

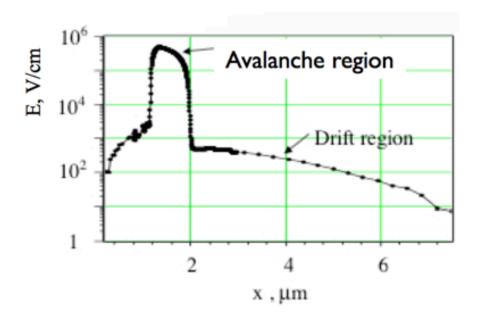
Gain :  $10^6$ 

Bias Voltage: < 100 V

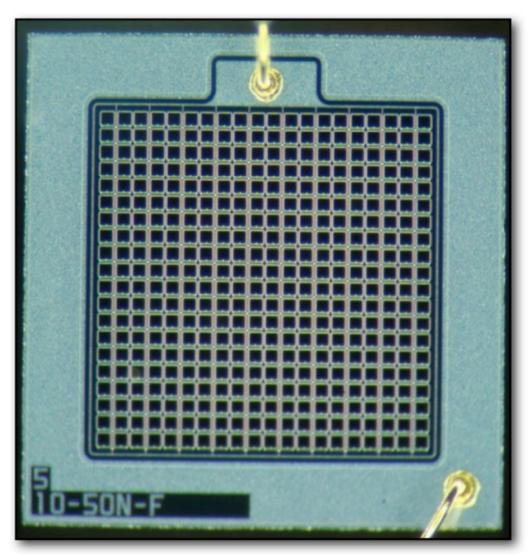
Efficiency: ca. 30 %

Insensitive to magnetic fields! Works at room temperature ...



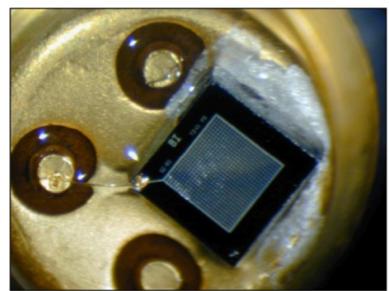


# SILICIUM PM



HAMAMATSU MPPC 400Pixels

One of the first SiPM Pulsar, Moscow

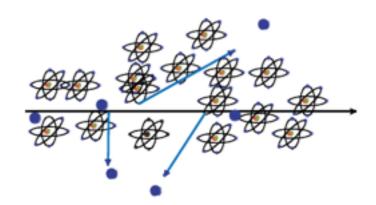


# COMPARISON of PHOTO-DETECTORS

	PMT	APD HPD		SiPM	
Photon					
detection					
efficiency:					
blue	20%	50%	20%	12%	
green - yel-	a few %	60-70%	a few %	15%	
low					
red	<1%	80%	<1%	15%	
Gain	$10^6 - 10^7$	100-200	$10^{3}$	$10^{6}$	
High voltage	1-2 kV	100-500 V	20 kV	25 V	
Operation in	problematic	OK	OK	OK	
the magnetic					
field					
Threshold	1 ph.e.	$\sim$ 10 ph.e.	1 ph.e.	1 ph.e.	
sensitivity					
S/N≫1					
Timing /10	$\sim 100 \text{ ps}$	a few ns	$\sim 100 \text{ ps}$	30  ps	
ph.e.					
Dynamic	$\sim 10^{6}$	large	large	$\sim 10^{3}/{\rm mm}^{2}$	
range					
Complexity	high (vac-	medium	very high	relatively	
	uum, HV)	(low noise	(hybrid	low	
		electronics)	technology,		
			very HV)		

#### CREATION of the SIGNAL

Charged particles traversing matter leave excited atoms, electron-ion pairs (gas, liquid) or electrons-holes pairs (solids) behind.



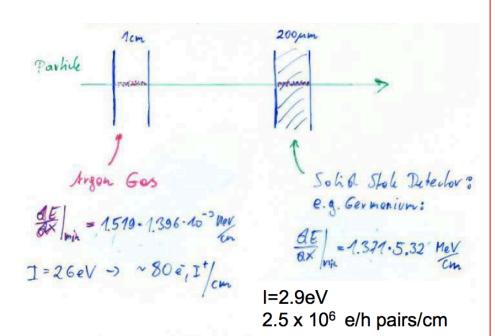
#### **Excitation**

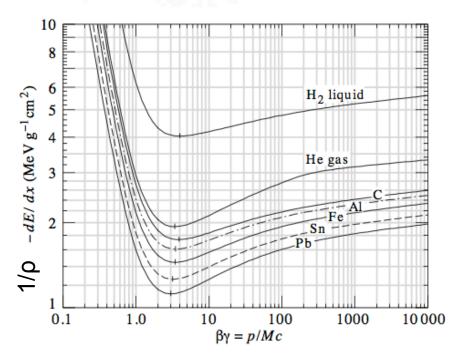
The photons emitted by the excited atoms in transparent materials can be detected with photon detectors like photomultipliers or semiconductor photon detectors.

#### **Ionisation**

By applying an electric field in the detector volume, the ionisation electrons and ions are moving, which induces signals on metal electrodes. These signals are then readout by appropriate readout electronics.

# GAS vs SOLID DETECTOR





The induced signals are readout by dedicated electronics.

The noise and preamplifier determines whether the signal can be registered: S/N >> 1.

The noise is characterized by the *Equivalent Noise Charge* (ENC) = charge signal at the input that produces an output signal equal to the noise

ENC of very good amplifiers can be as low as 50 e<sup>-</sup>, typical numbers are ~1000e<sup>-</sup>

In order to register a signal, the registered charge must be q>>ENC i.e. typically q>>1000 e<sup>-</sup>

Gas detector: q=80e<sup>-</sup>/cm: too small

Solid state detectors have 1000 times more density and factor 5-10 less ionisation energy: primary charge is 10<sup>4</sup>-10<sup>5</sup> times larger than in gases.

Gas detectors need internal amplification in order to be sensitive to single particle tracks.

Without internal amplification they can only be used for a large number of particles that arrive at the same time (ionisation chamber).

# LIQUID GAS DETECTOR: IONISATION DETECTOR for NA48 EM CALORIMETER

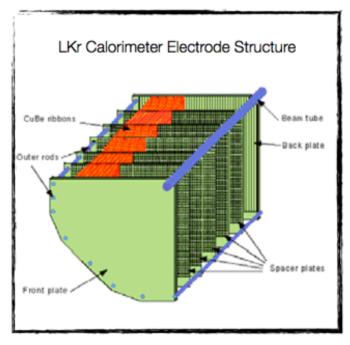
#### Liquid Krypton Ionization Chamber

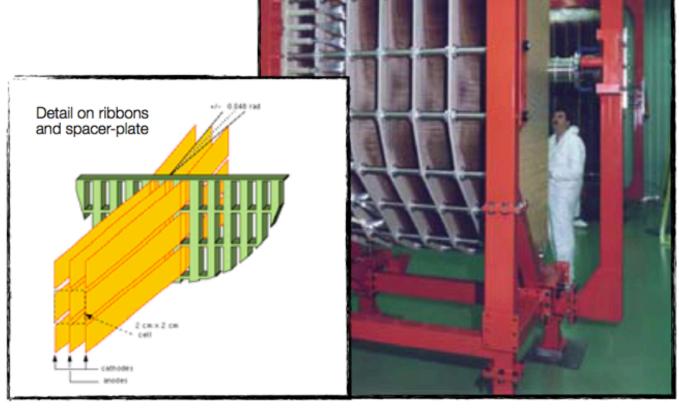
Homogeneous LKr; gain = 1

184 cells formed by thin electrodes; cell size: 2x2 cm<sup>2</sup>

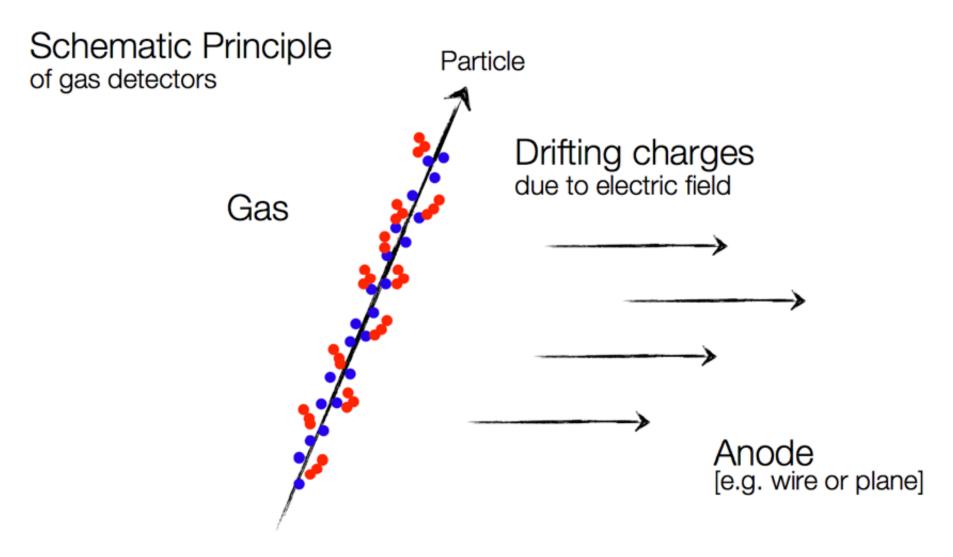
Each cell formed by two drift gaps sharing readout electrode

Electrodes: CuBe ribbons





# INTRODUCTION



- Primary Ionization
- Secondary Ionization (due to  $\delta$ -electrons)

#### INTRODUCTION

# Relevant Parameters for gas detectors

Differences due to  $\delta$ -electrons

Ionization energy

Ei

 $|a_T
angle = rac{L\cdot\left\langle rac{dE}{dx}
ight
angle}{W_{\cdot}}$ 

Average energy/ion pair

nρ

[about 2-6 times n<sub>p</sub>]

Average number of primary ion pairs [per cm]

Average number of ion pairs [per cm]

 $n_T$ 

[L: layer thickness]

δ-electrons lead to secondary ionization and limit spatial resolution; typical length scale of secondary ionization: 10 μm. Example: kinetic energy:  $T_{kin} = 1$  keV; gas: Isobutane → range: R = 20 μm ... [using  $R [g/cm^2] = 0.71$  ( $T_{kin}$ )<sup>1.72</sup> [MeV]; valid for  $T_{kin} < 100$  keV]

Gas	<z></z>	ρ [g/cm <sup>3</sup> ]	E <sub>i</sub> [eV]	W <sub>i</sub> [eV]	dE/dx [keV/cm]	n <sub>p</sub> [cm <sup>-1</sup> ]	n <sub>⊤</sub> [cm <sup>-1</sup> ]
He	2	1.66 · 10-4	24.6	41	0.32	5.9	7.8
Ar	18	1.66·10 <sup>-3</sup>	15.8	27	2.44	29.4	94
CH <sub>4</sub>	19	6.7 · 10-4	13.1	28	1.48	18	53
C <sub>4</sub> H <sub>10</sub>	34	2.42 · 10-3	10.6	23	4.50	46	195

#### INTRODUCTION

#### Ionization statistics:

Mean free path  $\lambda$ :

[typical values]

He 0.25 cm

Air 0.052 cm

Xe 0.023 cm

[→ **σ**<sub>i</sub>(He) ≈ 100 b]

Mean distance between two ionizations:  $\lambda = 1/(n_e \sigma_I)$ 

Mean number of ionizations:  $\langle n_p \rangle = L/\lambda$ 

 $\sigma_{\text{I}}$ : Ionization x-Section

ne: Electron density

L: Thickness

n<sub>p</sub> Poissonian distributed:

$$P(n_p, \langle n_p \rangle) = \frac{\langle n_p \rangle^{n_p} e^{-\langle n_p \rangle}}{n_p!}$$

 $P(0) = \exp(-L/\lambda)$  yields  $\lambda$ ,  $\sigma_1$  using (in)efficiency of gas-detectors

# Also important:

#### Mobility of charges:

Influences the timing behavior of gas detectors ...

#### Diffusion:

Influences the spatial resolution ...

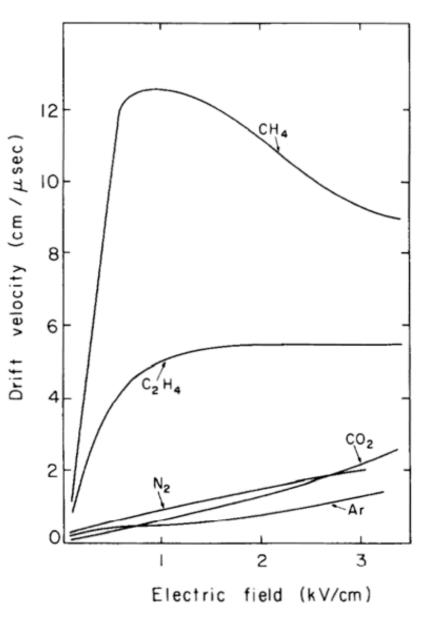
#### Avalanche process via impact ionization:

Important for the gain factor of the gas detector ...

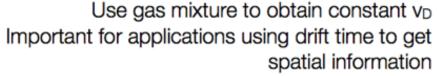
#### Recombination and electron attachment:

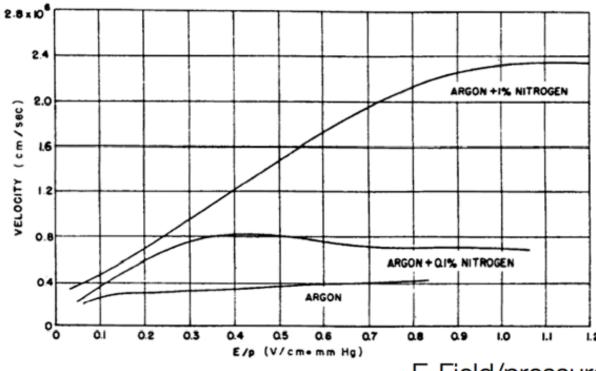
Admixture of electronegative gases (O2, F, Cl ...) influences detection efficiency ...

# DRIFT and DIFFUSION in GASES



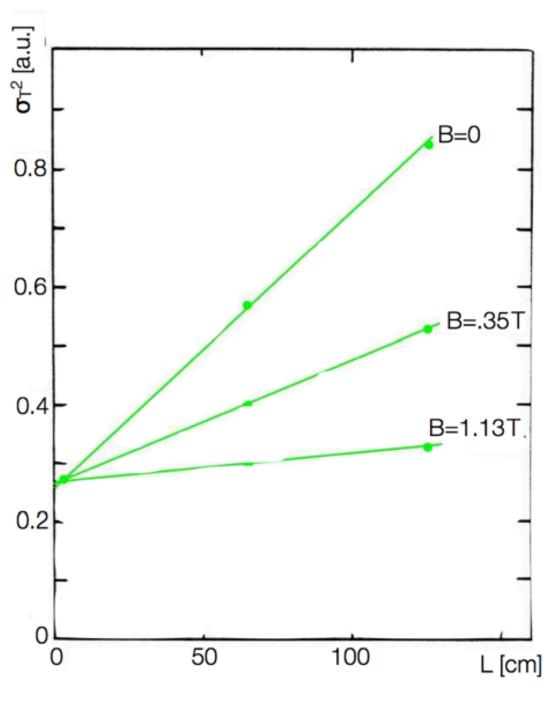
Drift velocity of electrons in several gases at normal conditions





E-Field/pressure

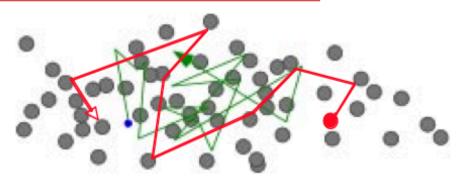
# DRIFT and DIFFUSION in GASES



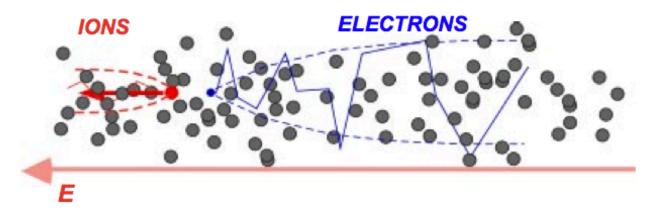
Transverse diffusion as function of drift length for different B fields

# **DIFFUSION IN GAS**

No electric field (E=0): thermal diffusion



With electric field (E>0): charge transport and diffusion



# DRIFT and DIFFUSION in GASES

#### For exact solution:

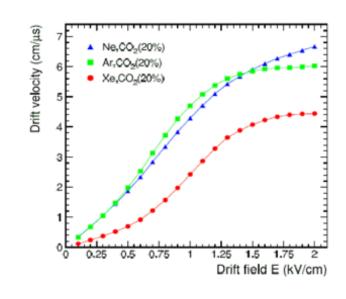
Solve "transport equation" for electron density distribution  $f(t, \vec{r}, \vec{v})$ :

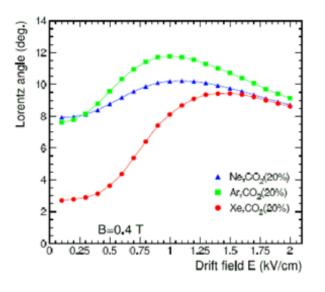
$$\frac{\partial f}{\partial t} \, + \, \vec{v} \frac{\partial}{\partial \vec{r}} f \, + \, \frac{\partial}{\partial \vec{v}} \left( \frac{e \vec{E}}{m} \, + \, \vec{\omega} \times \vec{v} \right) f \, = \, Q(t)$$

Typically needs to be solved numerically ...

Available Programs:

Magboltz Garfield





stochastic

# LOSS of ELECTRONS

# Electrons maybe lost during drift ... Possible processes:

#### i. recombination of ions and electrons

Depends on number of charge carriers and recombination coefficient ...

Generally not important ...

Recombination rate:

$$\Lambda = p_r \cdot n^+ n^-$$

⇒ Recombination coefficient ≈ 10<sup>-7</sup> cm<sup>3</sup>/s

#### ii. electron attachment

Electro-negative gases bind electrons; e.g.: O<sub>2</sub>, Freon, Cl<sub>2</sub>, SF<sub>6</sub> ... Attachment coefficient h strongly energy dependent ("Ramsauer effect") ...

Example  $O_2$ :  $h = 10^{-4}$ 

Collisions of electron per second: 10<sup>11</sup> Typical drift time of electron: 10<sup>-6</sup> s

Fraction lost:  $X_{loss} = 10^{-4} \ 10^{11} \ s^{-1} \ 10^{-6} \ s \cdot p = 10p$  $X_{loss} < 1\% \rightarrow p < 10^{-3}$ , i.e. less than 1 % admixture Oxygen should be kept out

#### DETECTING IONISATION WITH GAS DETECTOR

#### Criteria for optimal momentum resolution

many measurement points

large detector volume

very good single point resolution

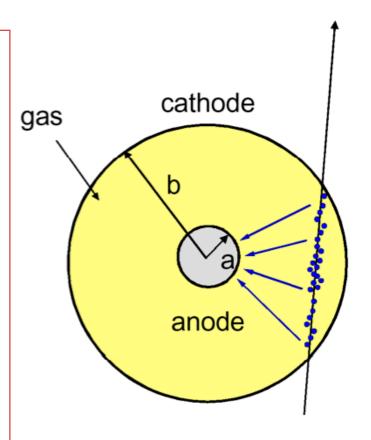
as little multiple scattering as possible

Gas detectors provide a good compromise and are used in most experiments. However

per cm in Argon, only ~100 electron-ion pairs are produced by ionisation;

this is to be compared with the noise of a typical preamplifier of ~1000 e-.

→ a very efficient amplification mechanism is required



# PRIMARY & TOTAL IONISATION YIELD in GAS

@ STP

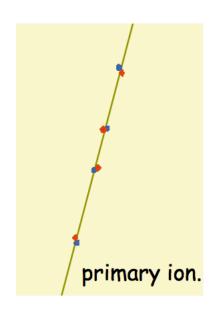
@ STP

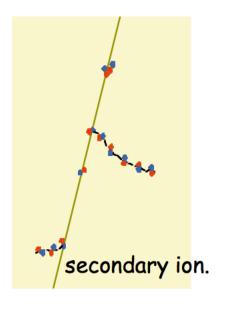
Total number of produced electron-ion pairs  $n_T = \frac{\Delta E}{W_i} = \frac{\frac{dE}{dx}\Delta x}{W_i}$ 

 $\Delta E$ : total energy loss in  $\Delta x$  and

W<sub>i</sub>: average energy loss per produced ion-pair: n<sub>T</sub>~2....7.n<sub>P</sub>

Gas	Density ρ [g/cm <sup>3</sup> ]	I <sub>0</sub> [eV]	W [eV]	n <sub>p</sub> [cm <sup>-1</sup> ]	n <sub>T</sub> [cm <sup>-1</sup> ]
H <sub>2</sub>	8.99 x 10 <sup>-5</sup>	15.4	37	5.2	9.2
He	1.78 x 10 <sup>-4</sup>	24.6	41	5.9	7.8
N <sub>2</sub>	1.23 x 10 <sup>-3</sup>	15.5	35	10	56
O <sub>2</sub>	1.43 x 10 <sup>-3</sup>	12.2	31	22	73
Ne	9.00 x 10 <sup>-4</sup>	21.6	36	12	39
Ar	1.78 x 10 <sup>-3</sup>	15.8	26	29	94
Kr	3.74 x 10 <sup>-3</sup>	14.0	24	22	192
Xe	5.89 x 10 <sup>-3</sup>	12.1	22	44	307
CO <sub>2</sub>	1.98 x 10 <sup>-3</sup>	13.7	33	34	91
CH <sub>4</sub>	7.17 x 10 <sup>-4</sup>	13.1	28	16	53
C <sub>4</sub> H <sub>10</sub>	2.67 x 10 <sup>-3</sup>	10.8	23	46	195





number primary electron-ion pain avg. ionisation pot. / shell elect. average energy loss./ion pair total number electron-ion pairs

# AMPLIFICATION of the SIGNAL in GAS

#### For a cylindral geometry

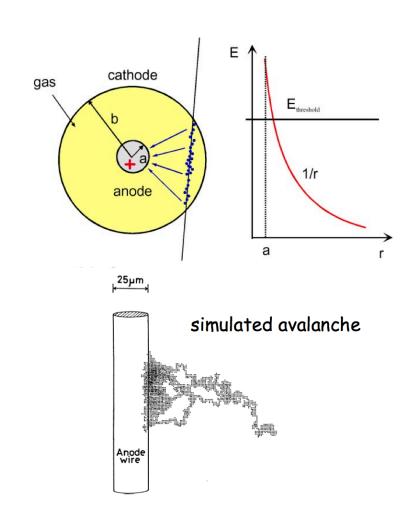
$$E(r) \propto \frac{1}{r}$$
 and  $V(r) \propto \ln \frac{r}{a}$ 

The primary electrons drift towards the positive anode:

due to 1/r dependence the electric field close to the very thin wires reaches values E>kV/cm

in between collitions with atoms electrons gain enough energy to ionise further gas molecules

exponential increase in number of electron-ion pairs close (fem µm) to the wire.



#### GAS DETECTORS with INTERNAL ELECTRON MULTIPLICATION

**Principle:** At sufficiently high electric fields (100 kV/cm) the electrons gain energy in excess of ionisation energy: secondary ionisation etc...

 $dN = N \cdot \alpha \cdot dx$ 

a: Towsend coefficient

 $N(x) = N_0 e^{-\alpha x}$ 

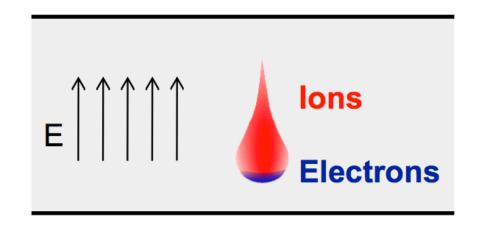
 $N/N_0$  = A Amplification, Gas Gain

#### Avalanche in a homogeneous field

Problem: High field at electrode surface → breakdown

#### In an inhomogeneous field

$$\alpha(E) \rightarrow N(x) = N_0 e^{-\alpha(E(x')).dx'}$$



### **AVALANCHE FORMATION**

Wire with radius a~10-25µm in a tube of radius b~1-3 cm

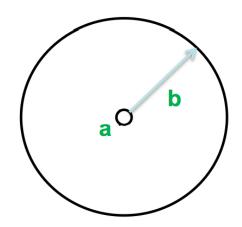
$$E(r) = rac{\lambda}{2\piarepsilon_0}rac{1}{r} = rac{V_0}{\lnrac{b}{a}}rac{1}{r}, \qquad V(r) = rac{V_0}{\lnrac{b}{a}}\lnrac{r}{a},$$

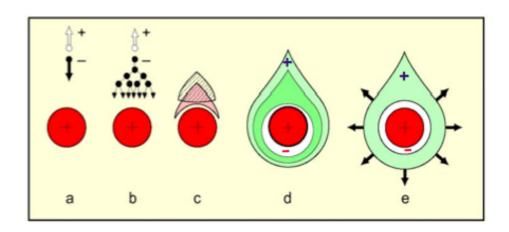
Electric field close to a thin wire (100-300 kV/cm) e.g.

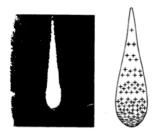
$$V_0=1000V$$
,  $a=10\mu m$ ,  $b=10$  mm,  $E(a)=150kV/cm$ 

Electric field is sufficient to accelrate electrons to energies which are sufficient to produce secondary ionisation

- → electron avalanche
- → signal







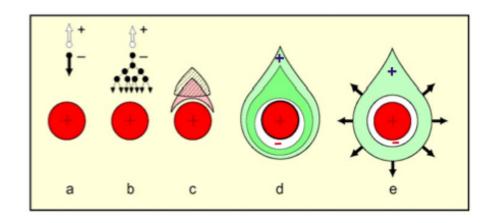
picture taken with cloud chamber

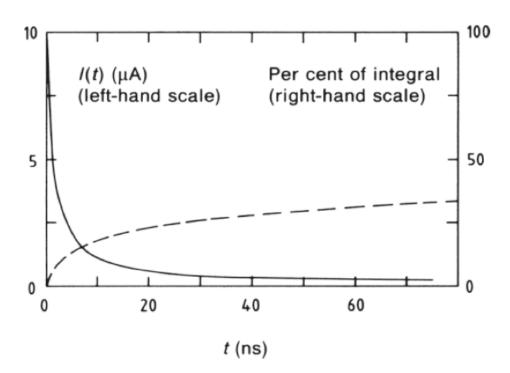
#### WIRE CHAMBER: SIGNAL from ELECTRON AVALANCHE

The electron avalanche happens very close to the wire; First multiplication only around R=2 x wire radius. Electrons are moving to the wire surface very quickly (<<1ns). ions are drifting towards the tube wall ( $\sim100~\mu$ s).

The signal is characterised by a very fast spike from the electrons and a long tail.

The total charge induced by the electrons, i.e. the charge of the current spike due to the short electron movement, amounts to 1-2% of the total induced charge.





### **MODE of OPERATIONS**

#### Ionization mode:

full charge collection no multiplication; gain ≈ 1

#### Proportional mode:

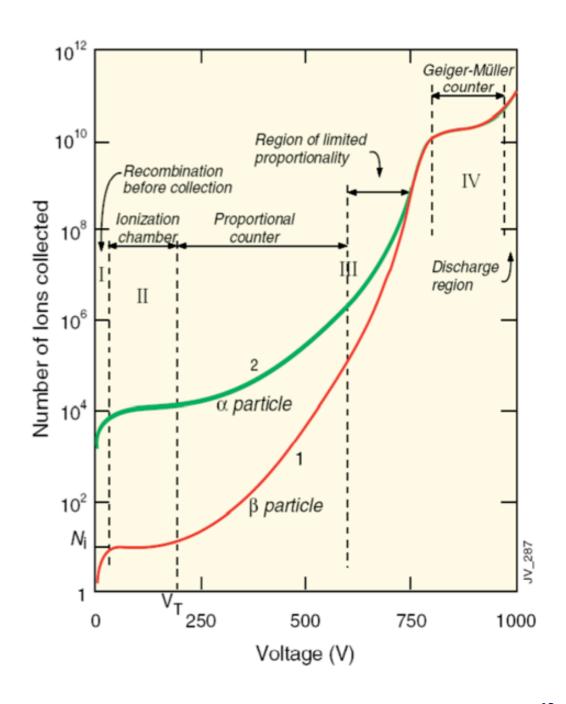
multiplication of ionization signal proportional to ionization measurement of dE/dx secondary avalanches need quenching; gain ≈ 10<sup>4</sup> – 10<sup>5</sup>

# Limited proportional mode: [saturated, streamer]

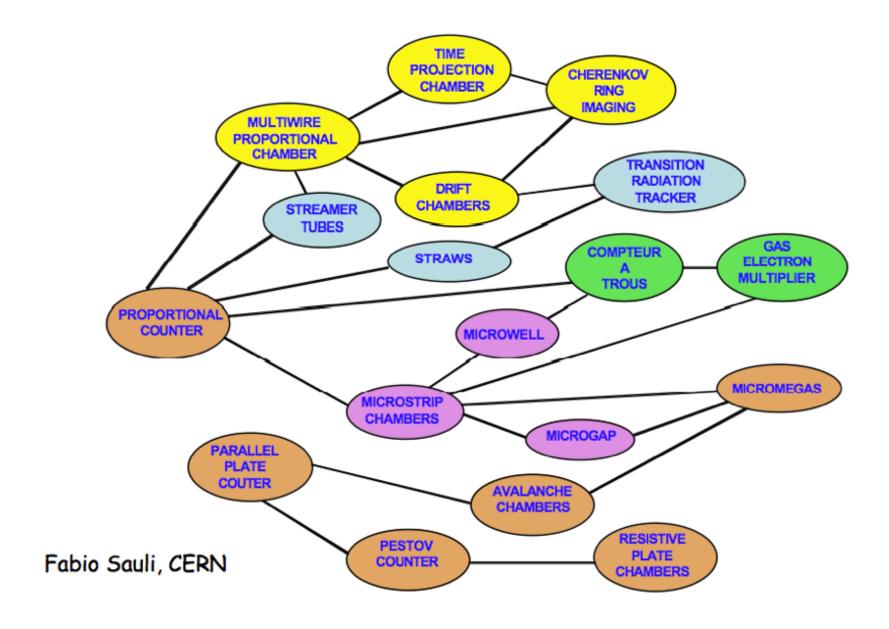
strong photoemission requires strong quenchers or pulsed HV; gain ≈ 10<sup>10</sup>

#### Geiger mode:

massive photoemission; full length of the anode wire affected; discharge stopped by HV cut



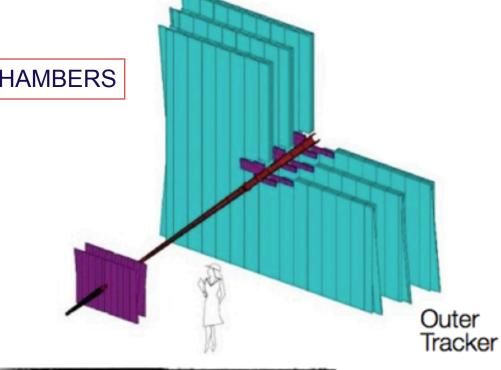
## FAMILY TREE OF GASEOUS DETECTORS

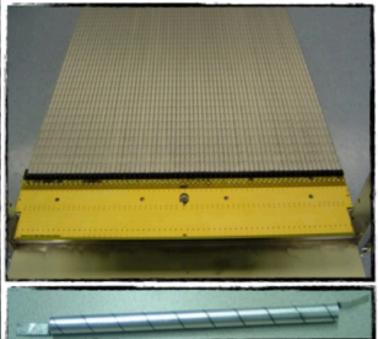


# LHCb OUTER TRACKER





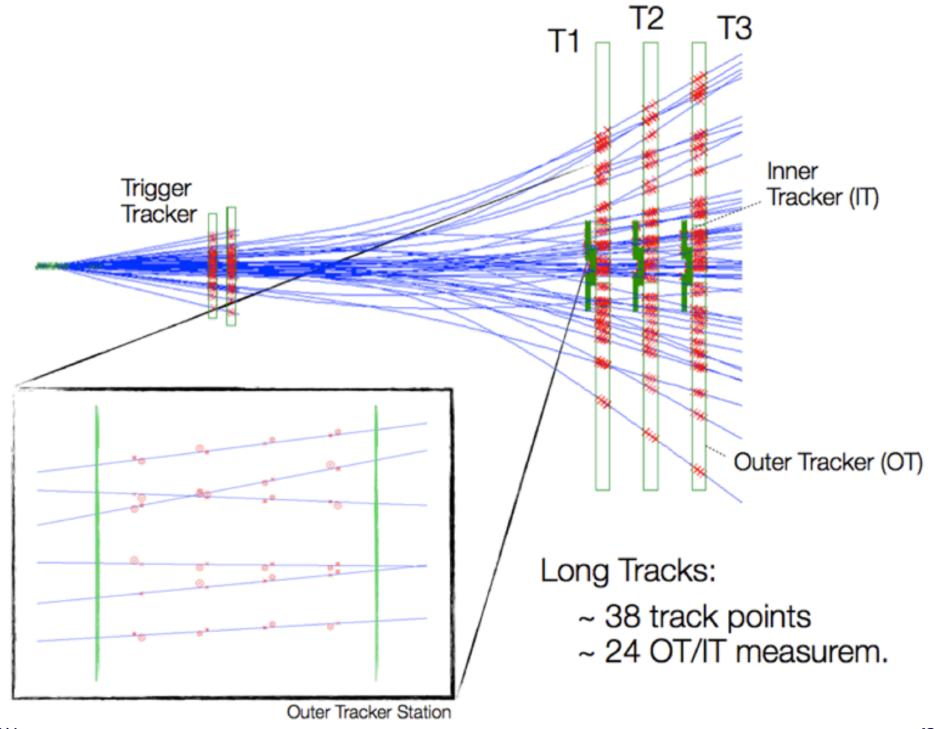




Straw Tubes [double layers]

3 Chambers [4 layers á 18 modules]

# LHCb OUTER TRACKER



# MULTI WIRE PROPORTIONAL CHAMBERS

Classic geometry - Charpak 1968

One plane with thin senses wires is placed between two parallel plates

Wire distance ~2-5 mm

Distance between cathode planes ~10 mm

Electrons (v~5cm/µs) are collected with 100 ns. The ion tail can be eliminated by electronics filters

→ pulse of < 100 ns length

For 10% occupancy→one pulse every µs

- → 1MHz/wire rate capacity
- → Compare with bubble chamber at 10 Hz

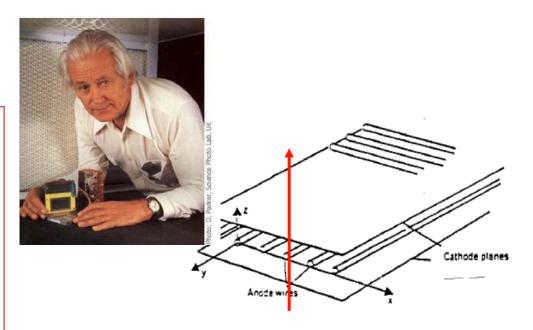
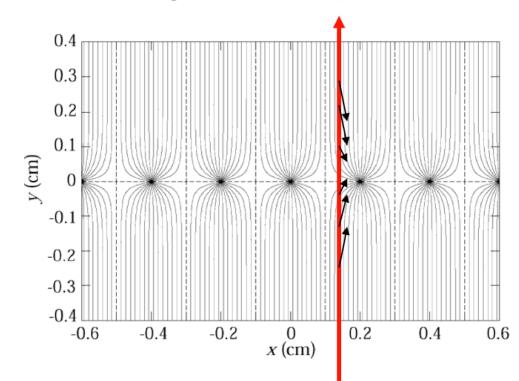
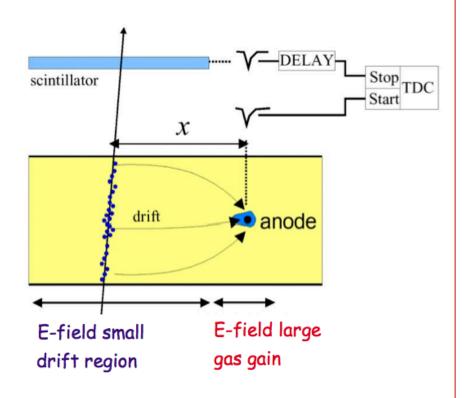


Abbildung 2.27: Vieldrahtproportionalkammer.



### PRINCIPLE of DRIFT CHAMBER



Measure arrival time t<sub>1</sub> of electrons at anode wire relative to reference t<sub>0</sub>

external definition of time reference to (here by a fast scintillator signal)

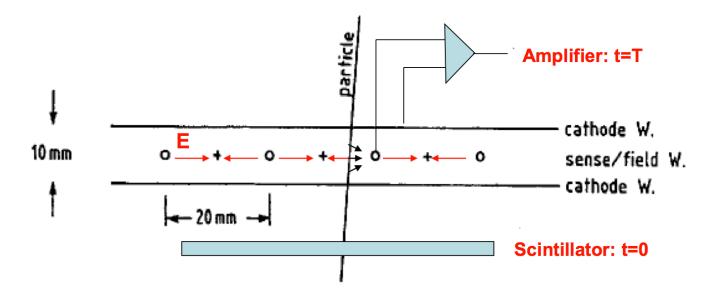
x-coordinate given by 
$$x = \int_{t_0}^{t_1} v_D(t) dt$$

if drift velocity v<sub>D</sub> constant over full drift distance

$$x = v_D(t_1 - t_0) = v_D \Delta t$$

advantage of drift chambers: much larger sensitive volume per readout channel

#### DRIFT CHAMBERS



In an alternative sequence of wires with different potentials one finds an electric field between the *sense wires* and the *field wires*.

The electrons are moving to the sense wire and produce an avalanche which induces a signal that is read out by electronics

The time between the passage of the particle and the arrival of the electrons at the wire is measured.

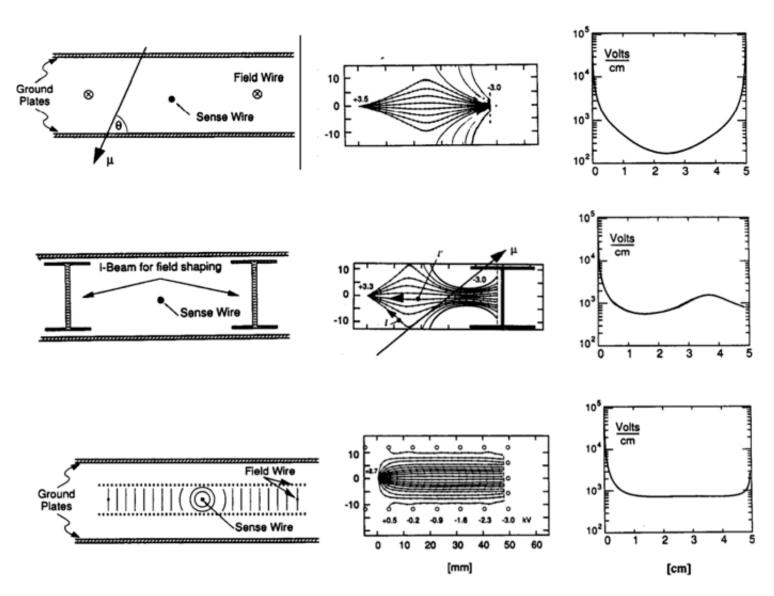
The drift time T is a measure of the position of the particle.

By measuring the drift time, the wire distance can be increased (wrt to MWPC)

→ save electronics channels

# DRIFT CHAMBERS, TYPICAL GEOMETRIES

#### Electric Field ≈ 1kV/cm



U.Becker Instr. of HEP, Vol#9, p516 World Scientific (1992) ed F.Sauli

# OPAL DRIFT CHAMBER



## THE GEIGER COUNTER RELOADED: DRIFT TUBE

ATLAS MDT R(tube) =15mm

Calibrated Radius-Time correlation

TDC

Amplifier Discriminator

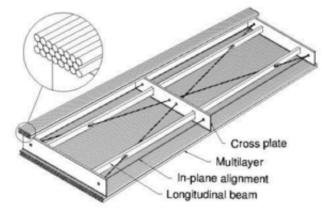
Primary electrons are drifting to the wire.

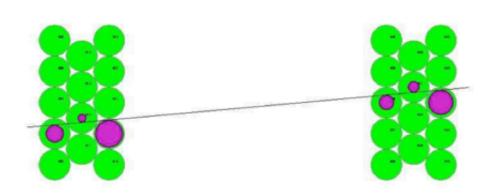
Electron avalanche at the wire.

The measured drift time is converted to a radius by a (calibrated) radius-time correlation.

Many of these circles define the particle track.

#### **ATLAS Muon Chambers**





ATLAS MDTs, 80µm per tube

## THE GEIGER COUNTER RELOADED: DRIFT TUBE

Atlas Muon Spectrometer, 44m long, from r=5 to11m.

1200 Chambers

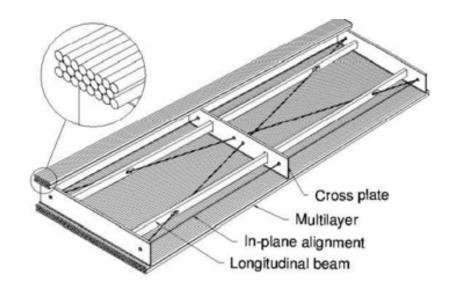
6 layers of 3cm tubes per chamber.

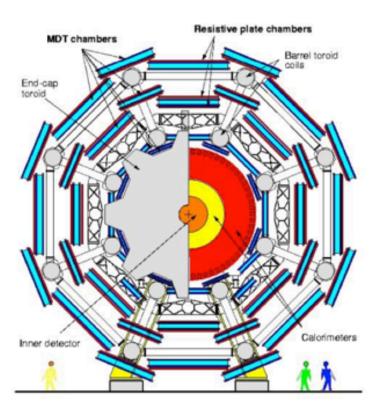
Length of the chambers 1-6m!

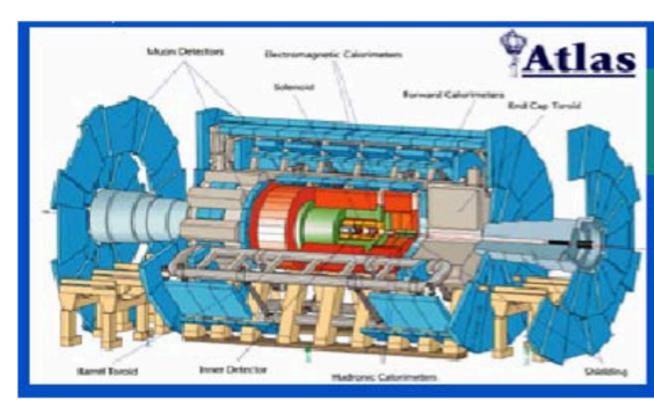
Position resolution: 80μm/tube, <50μm/chamber (3 bar)

Maximum drift time ≈700ns

Gas Ar/CO<sub>2</sub> 93/7







U3-U1.11.2U14

## TIME PROJECTION CHAMBER

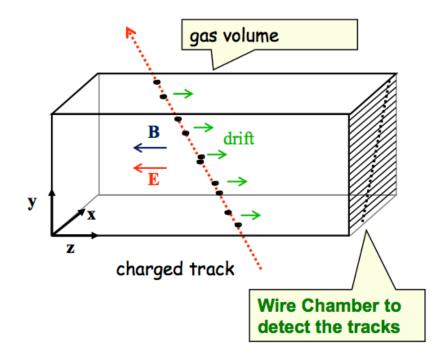
Gas volume with parallel E and B field.

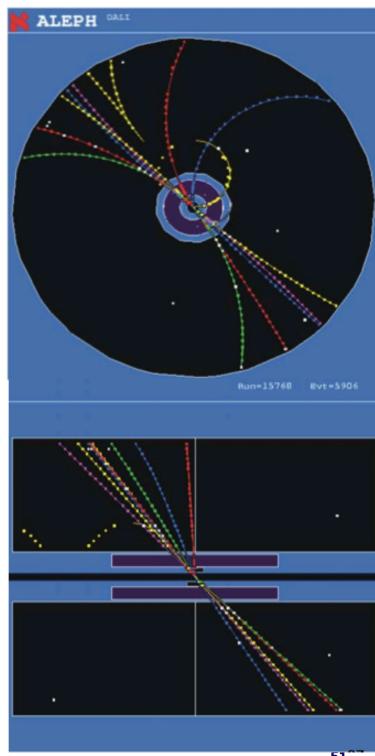
B for momentum measurement.

Positive effect:

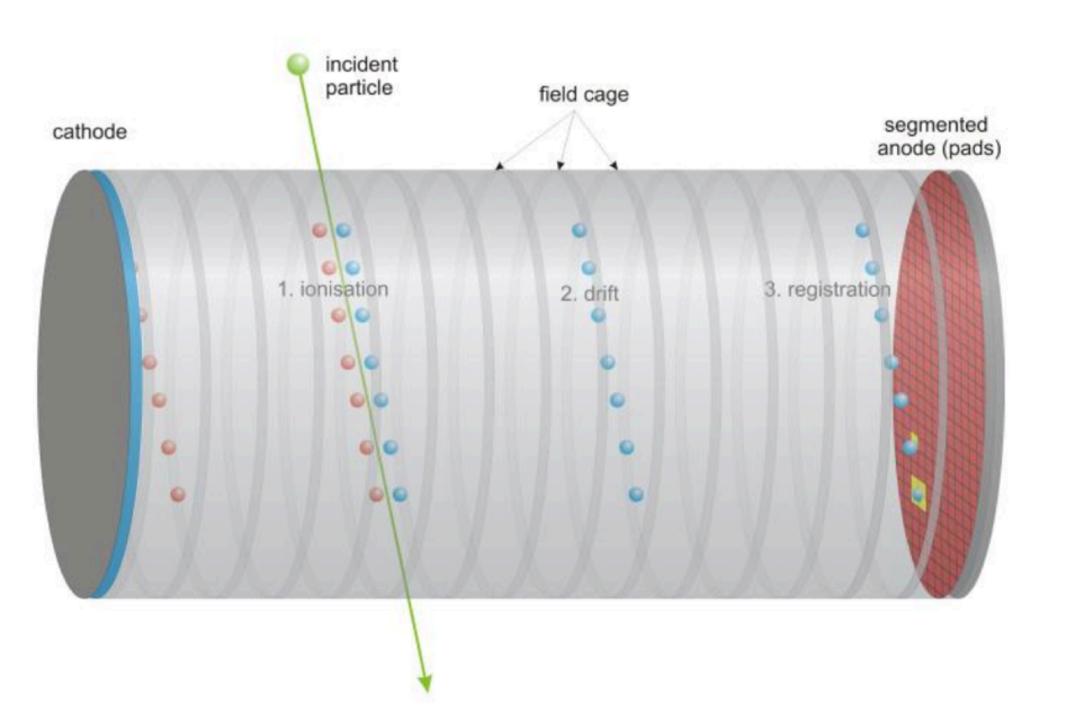
Diffusion is strongly reduced by E//B (up to a factor 5)

Drift fields 100-400V/cm - Drift times 10-100 µs and distance up to 2.5 m.

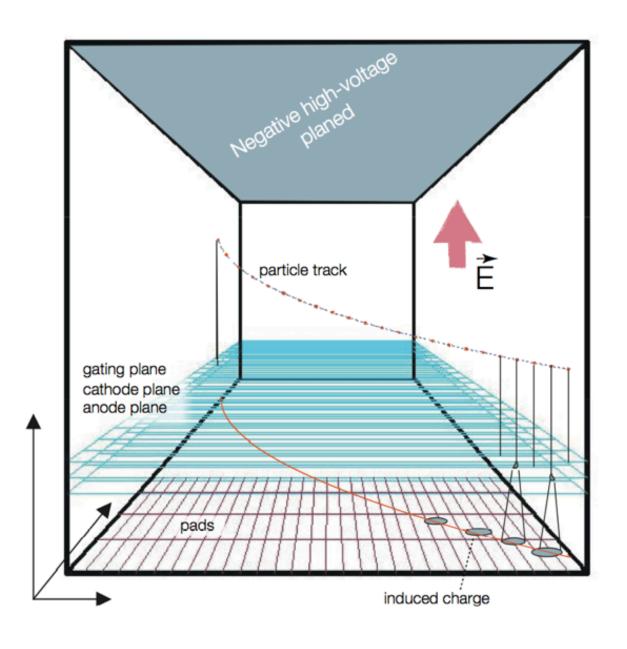




## TRACKING DETECTOR: TIME PROJECTION CHAMBER



# DRIFT CHAMBER: SCHEMATIC



#### Advantages:

Complete track within one detector yields good momentum resolution

Relative few, short wires (MWPC only)

Good particle ID via dE/dx

Drift parallel to B suppresses transverse diffusion by factors 10 to 100

#### Challenges:

Long drift time; limited rate capability [attachment, diffusion ...]

Large volume [precision]

Large voltages [discharges]

Large data volume ...

Extreme load at high luminosity; gating grid opened for triggered events only ...

#### Typical resolution:

z: mm; x: 150 - 300 µm; y: mm

dE/dx: 5 - 10%

### **ALICE TPC**

#### ALICE TPC:

Length: 5 meter Radius: 2.5 meter Gas volume: 88 m<sup>3</sup>

Total drift time: 92  $\mu$ s High voltage: 100 kV

End-cap detectors: 32 m<sup>2</sup> Readout pads: 557568

159 samples radially 1000 samples in time

Gas: Ne/CO<sub>2</sub>/N<sub>2</sub> (90-10-5) Low diffusion (cold gas)

Gain: > 104

Diffusion:  $\sigma_t = 250 \ \mu m$ Resolution:  $\sigma \approx 0.2 \ mm$ 

 $\sigma_p/p \sim 1\% p$ ;  $\epsilon \sim 97\%$  $\sigma_{dE/dx}/(dE/dx) \sim 6\%$ 

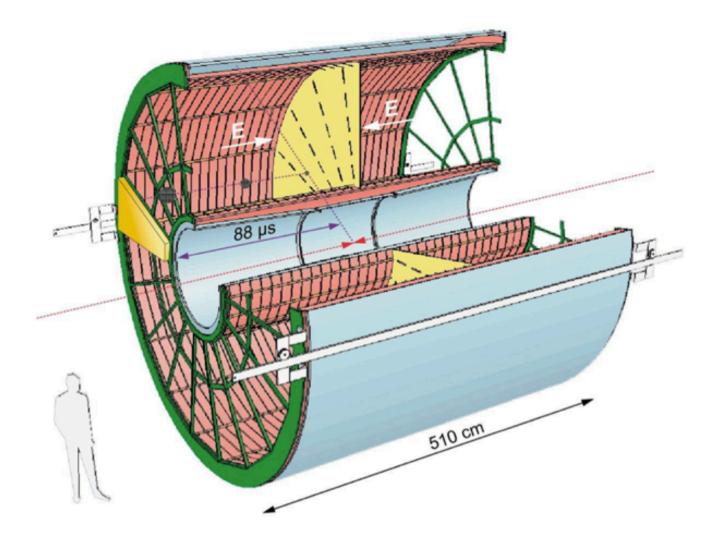
Magnetic field: 0.5 T

Pad size: 5x7.5 mm<sup>2</sup> (inner)

6x15 mm<sup>2</sup> (outer)

Temperature control: 0.1 K

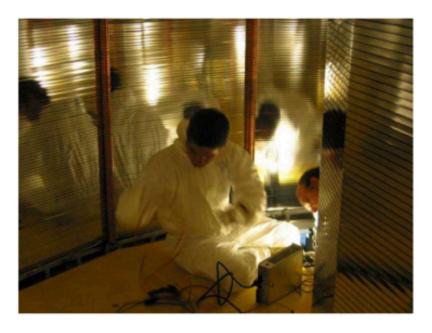
[also resistors ...]



Material: Cylinder build from composite material of airline industry (X<sub>0</sub>= ~ 3%)

# CONSTRUCTION of the ALICE TPC





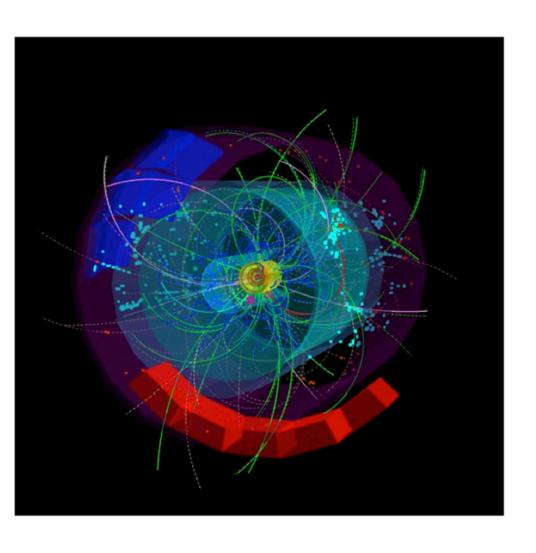
**ALICE TPC Construction** 

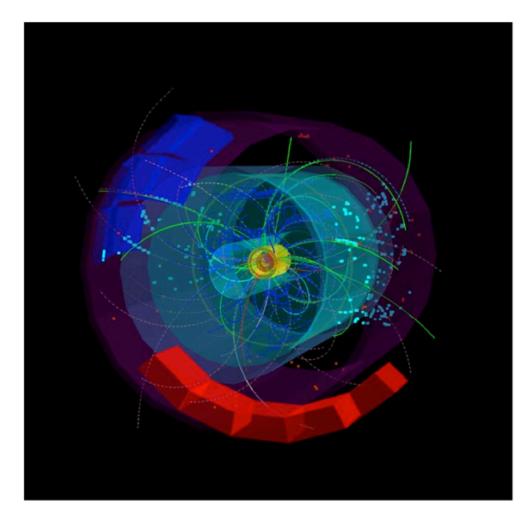
A visit inside the TPC.



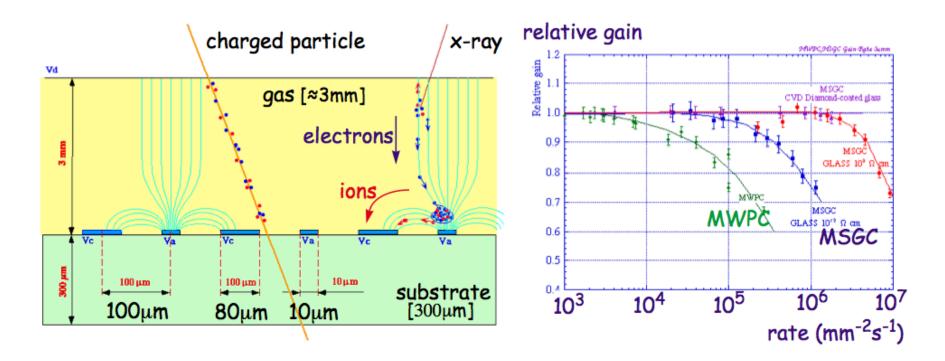
W. Riegler/CERN

# FIRST 7 TeV COLLISIONS in the ALICE TPC (03.2010)





### MICRO STRIPS PLATE CHAMBERS



#### **ADVANTAGE**

Very precise and small anode/cathode structures can be produced with lithographical methods → very good position resolution

High mechanical stability

Small drift distance for ions → high rate capability

# RESISTIVE PLATE CHAMBER (RPC)

Robust and simple detector no wire

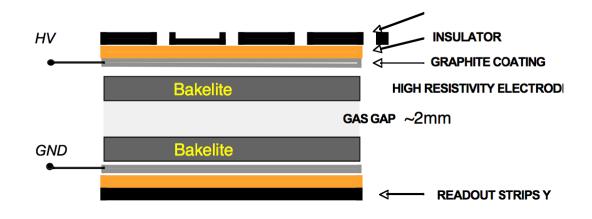
Relatively cheap

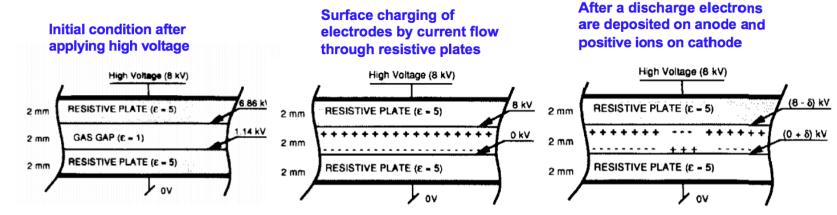
Well suited for large areas

(muon systems)

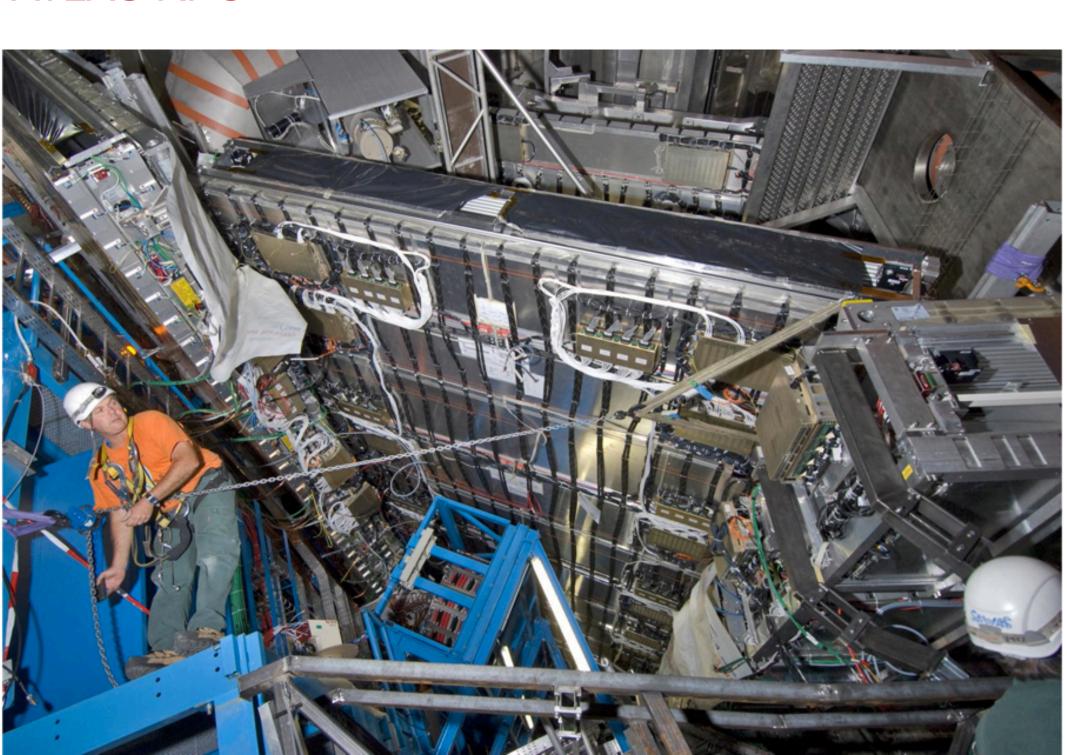
Fast signal < 5ns → trigger

Good rate capability few kHz/cm<sup>2</sup>





# ATLAS RPC



### **GEM & MICROMEGAS**

In the late 90's developped by F. Sauli at CERN [NIM A386 (1997), 531]

Typical gain of 10<sup>3</sup> at 500 V

Can stack several stages on top of each other

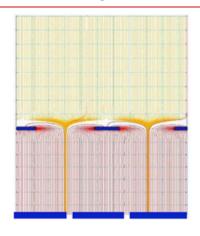
Large total gain for relatively moderate HV

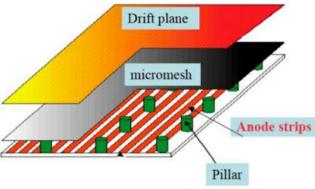
#### **MICROMEGAS**

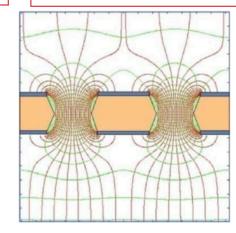
Narrow gap (50-100µm) PPC with thin cathode mesh Insulating gap-restoring wires or pillars

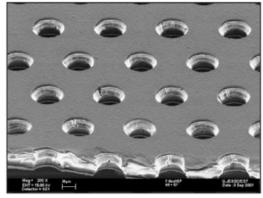
#### **GEM**

Thin metal-coated polymer foils 70 µm holes at 140 mm pitch









F. Sauli, Nucl. Instr. and Methods A386(1997)531

### SUMMARY on GAS DETECTORS

Wire chambers feature prominently at LHC. A decade of very extensive studies on gases and construction materials has lead to wire chambers that can track up to MHz/cm<sub>2</sub> of particles, accumulate up to 1-2C/cm of wire and 1-2 C/cm<sup>2</sup> of cathode area.

While silicon trackers currently outperform wire chambers close to the interaction regions, wire chambers are perfectly suited for the large detector areas at outer radii.

Large scale next generation experiments foresee wire chambers as large area tracking devices.

The Time Projection Chamber, if the rate allows its use, is unbeatable in terms of low material budget and channel economy.

Gas detector can be simulated very accurately due to excellent simulation programs.

Novel gas detectors, the Micro Pattern Gas Detectors, have proven to work efficiently at high rate, low material budget trackers in the *regime* between silicon tracker and large wire chambers.

### SOLID DETECTORS

Silicon detectors: a kind of solid-state ionisation chamber

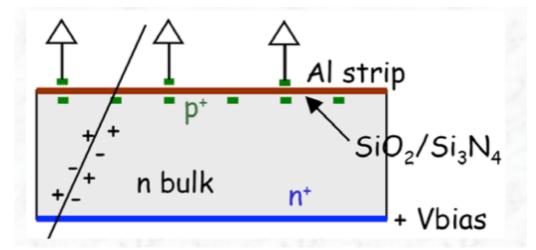
Si-detector concepts started in the 80's: expensive and difficult at first

Increased commercial use of Si-photolithography and availibitiy of VLSI (Very Large Scale Integration) electronics lead to a boom for Si-detectors in the 90's - and it still goes on, though still some R&D to do, in particular concerning radiation hardness

Nearly all HEP experiments use Silicon detectors as innermost highprecision tracking device

HEP experiments are now exporting Si-technology back to the commercial

world (Medical imaging).



### Si DETECTORS - BASIC PROPERTIES

Silicon: type IV element, 1.1 eV band gap

Intrinsic conductivity very low:  $\sigma_i = e.n_i(\mu_e + \mu_h)$ 

Carrier density at 300K

1.5 10<sup>10</sup>/cm<sup>3</sup> compared to 5.10<sup>22</sup> Si-atoms/cm<sup>3</sup> often dominated by impurities

Mobility  $\mu_e \sim 1800 \text{ cm}^2/\text{Vs}$ ,  $\mu_h \sim 1600 \text{ cm}^2/\text{Vs}$  in diamond

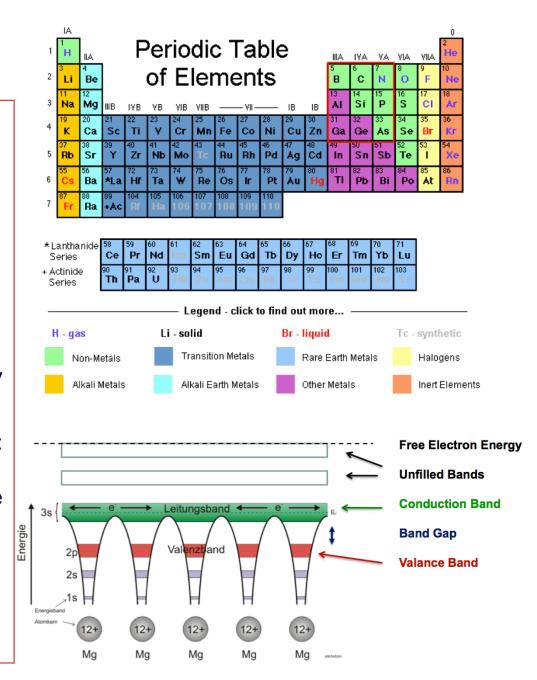
Doping: small admixtures of type III or type V elements increase conductivity

Donours like Phosphorous give extra electrons: n-type Si

Acceptors (e.g. Boron) supply extra hole: p-type Si

Contact between p- and n-Si forms p-n junction Doping dominates conductivity as  $n_i << n_D$ 

For n-type Si:  $\sigma_D = e.n_D.\mu_e$ 



#### BASIC SEMIN CONDUCTOR PROPERTIES

#### Intrinsic semiconductor:

Very pure material; charge carriers are created by thermal, optical or other excitations of electron-hole pairs; N<sub>electrons</sub> = N<sub>holes</sub> holds ...

Commonly used: Silicon (Si) or Germanium (Ge); four valence electrons ...

#### Doped or extrinsic semiconductor:

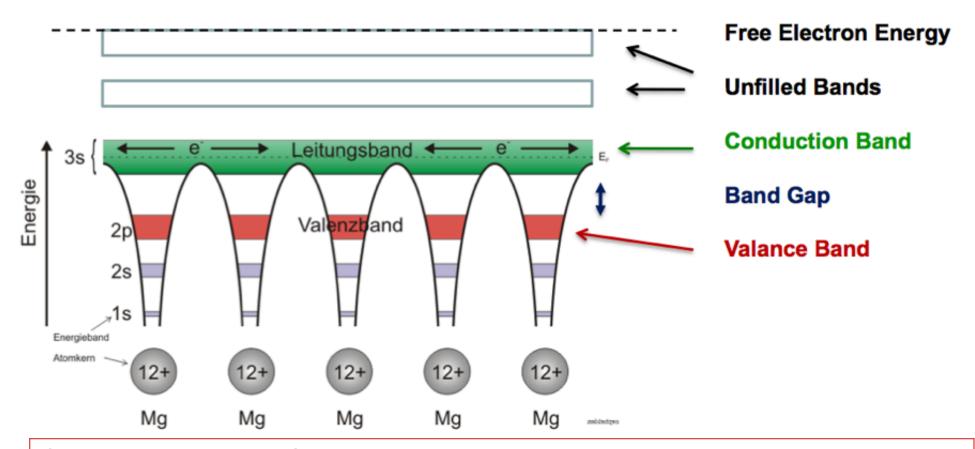
Majority of charge carriers provided by donors (impurities; doping)

n-type: majority carriers are electrons (pentavalent dopants)

p-type: majority carriers are positive holes (trivalent dopants)

Pentavalent dopants (electron donors): P, As, Sb, ... [5<sup>th</sup> electron only weakly bound; easily excited into conduction band]

Trivalent dopants (electron acceptors): Al, B, Ga, In, ... [One unsaturated binding; easily excepts valence electron leaving hole]



#### Conductor, Insulator, Semiconductor

In case the conduction band is filled, the crytal is conductor

In case the conduction band is empty and *far away* from the valence band, the crystal is an insulator

In case the conduction band is empty, but the distance to the valence is mall, the crystal is a semi-conductor.

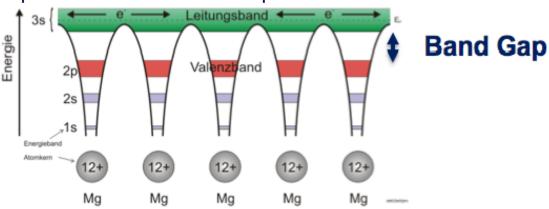
#### Band Gap, e-h pair Energy

The energy gap between the last filled band - the valence band - and the conduction band is called band gap E<sub>g</sub>.

The band gap of Diamond/Silicon/Germanium is 5.5/1.12/0.66 eV.

The average energy to produce an electron/hole pair for Diamond/Silicon/Germanium is 3, 3.6,

2.9 eV.



#### Temperature, charged particle detection

In case an electron in the valence band gains energy by some process, it can be excited into the conduction band and a hole in the valence band is therefore created.

Such a process can be the passage of a charged particle, but also thermal excitation probability is e-Eg/kT

The number of electrons in the conduction band is therefore incerasing with temperature i.e. the conductivity of a semiconductor increases with tempreature.

#### Electron, hole movement

It is possible to treat electrons in the conduction band and holes in the valence band similar to free particles, but with an effective mass different from elementary electrons, not embedded in the lattice.

This mass is furthermore dependant on other parameters such as the direction of movement wrt the crystal axis. All this follows from the Quantum Mechanics treatement of the crystal.

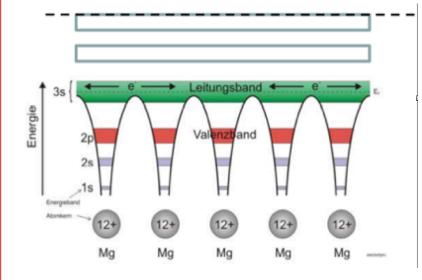
#### Cooling

If we want to use a semiconductor as a detector for charged particles, the number of charge carriers in the conduction band due to the thermal excitation must be smaller than the number of charge carriers in the conduction band produced by the passage of the charged particle

Diamond (E<sub>g</sub>=5.5 eV) can be used for particle detection at room temperature.

Silicon (E<sub>g</sub>=1.12 eV) and Germanium (E<sub>g</sub>=0.66 eV) must be cooled, or the free charge carriers must be eliminated by other tricks

→ doping



#### **Primary ionisation**

The average energy to produce an electron/hole pair is for Diamond/Silicon/Germanium: 13/3.6/2.9 eV.

Comparing to gas detector, the density of a solid is about a factor 1000 larger than that of a gas and the energy to produce electron/hole pair e.g. sir Si is a factor 7 smaller than the energy to produce an electron/ion pair in Argon.

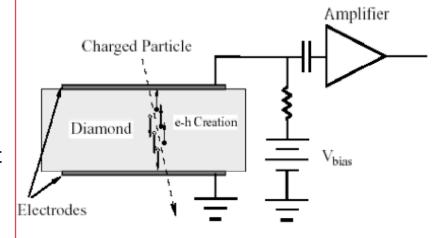
#### Solid state vs gas detector

The number of primary charges in a Si detector is therefore about 10<sup>4</sup> times larger than the one in gas

gas detectors need internal charge amplification solid state detectors do not need internal amplification

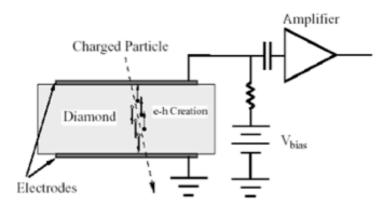
While in gas detectors the velocity of electrons and ions differs by a factor 1000, the velocity of electrons and holes in many semiconductors is quite similar

very short signal



## DIAMOND DETECTORS

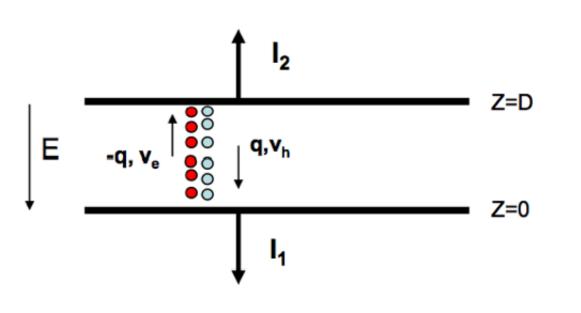
Typical thickness of a few 100 µm <1000 charge carrieurs/cm³ at room temperature due to large band gap

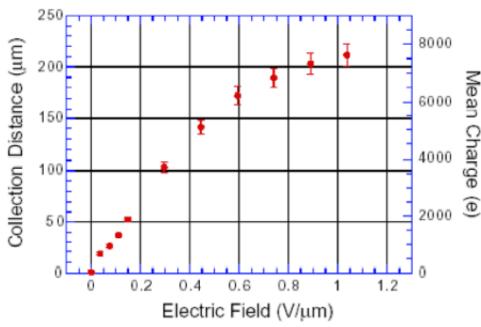


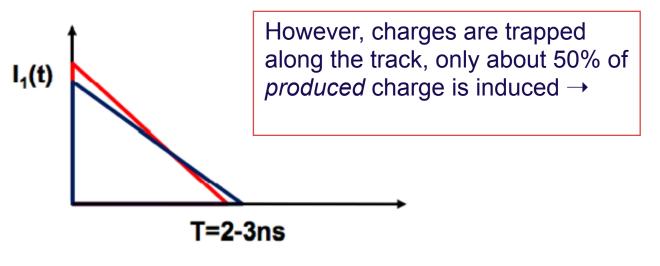
#### **Velocity**

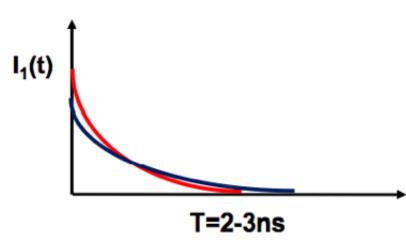
 $\mu_e$ =1800 cm<sup>2</sup>/Vs,  $\mu_h$ =1600 cm<sup>2</sup>/Vs Velocity =  $\mu$ E - E=10kV/cm  $\rightarrow$  v=180  $\mu$ m/ns  $\rightarrow$  very fast signals of only a few ns length.

# DIAMOND DETECTORS



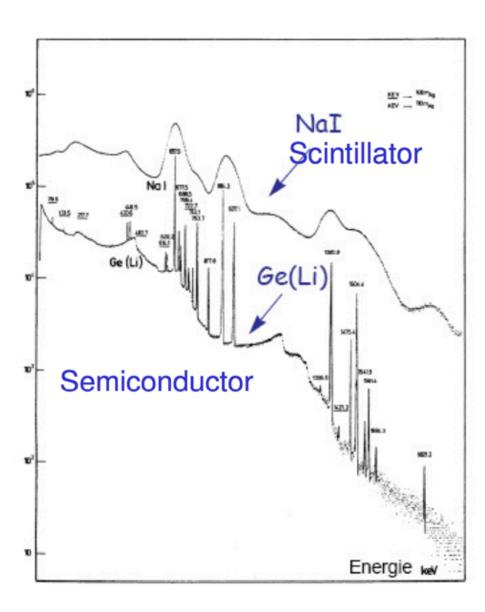






## SOLID STATE DETECTOR for ENERGY MEASUREMENT

**ILLUSTRATION** 



### SILICON DETECTORS

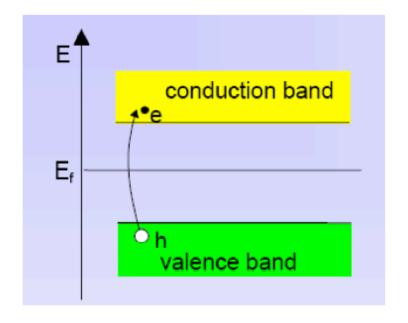
#### **Velocity**

 $\mu_e$ =1450 cm<sup>2</sup>/Vs,  $\mu_h$ =505 cm<sup>2</sup>/Vs, 3.63 eV per e-h pair

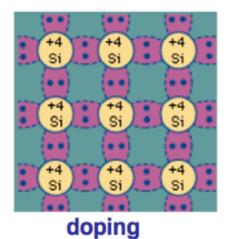
~33000 e/h pairs in 300 µm of silicon

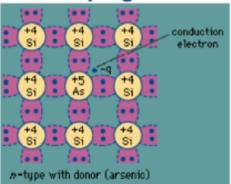
However: free charge carriers in Si For T=300K, e/h=1.45 x  $10^{10}$ /cm<sup>3</sup> but only 33000 e/h pairs in 300µm produced by a high energy particle.

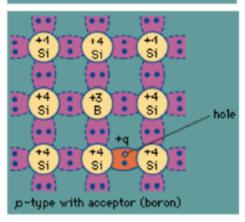
How is it that Si is used a solid state detector?



#### DOPING of SILICON





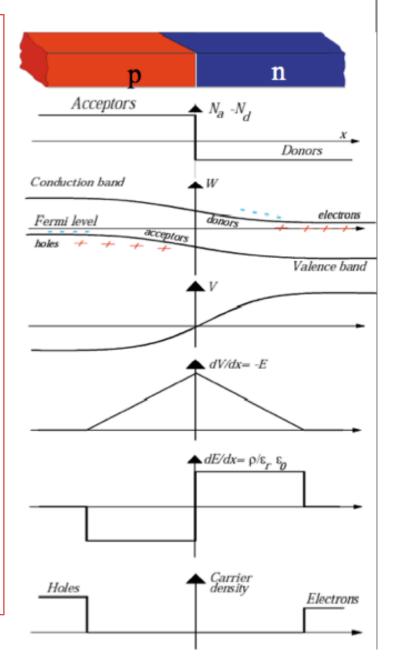


In a silicon crystal at a given temperature the number of electrons in the conduction band is equal to the number of holes in the valence band.

Doping Si with Arsen (+5) it becomes an n-type conductor (more electrons than holes)

Doping Si with Boron (+3) it becomes a p-type conductor (more holes than electrons)

Bringind p and n in contact makes a diode



#### SILICIUM DIODE USED as a PARTICLE DETECTOR

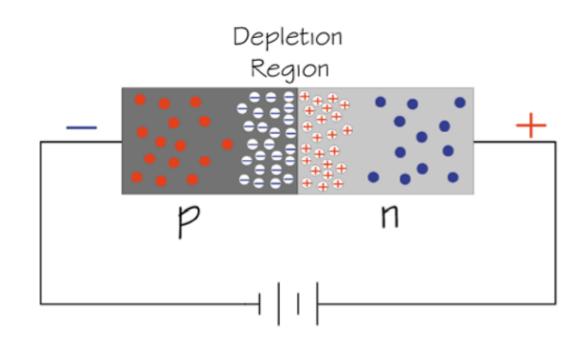
At the p-n junction the charges are depleted and a zone free of charge carriers is established

By applying a voltage, the depletion zone can be extended to the entire diode

→ highly insulating layer

An ionising particle produces free charge carriers in the diode, which drift in the electric field and induce an electrical signal on the metal of the electrodes.

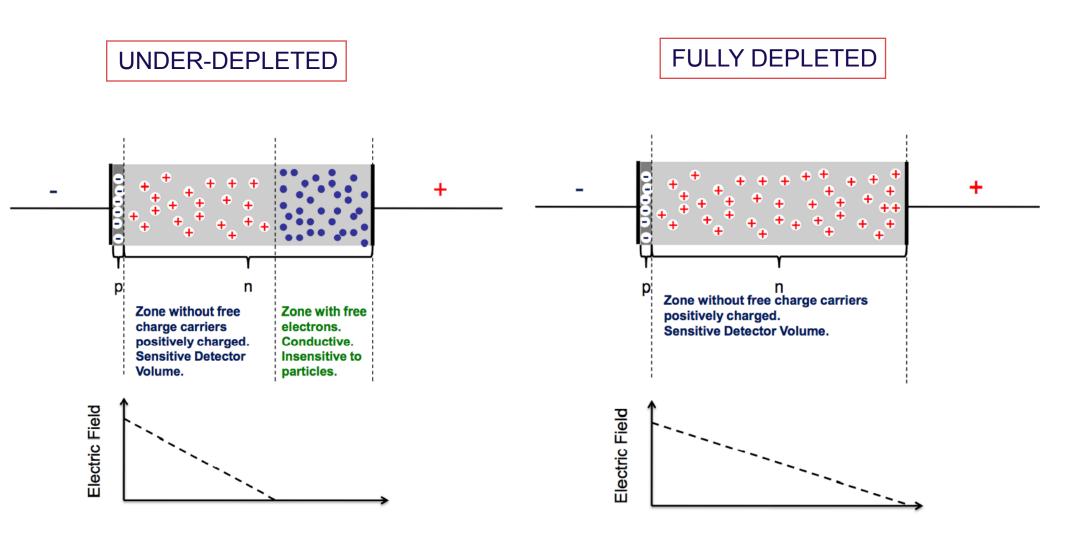
As silicon is the most commonly used material in the electronics industry, it has one big advantage with respect to other materials, namely highly developed technology.



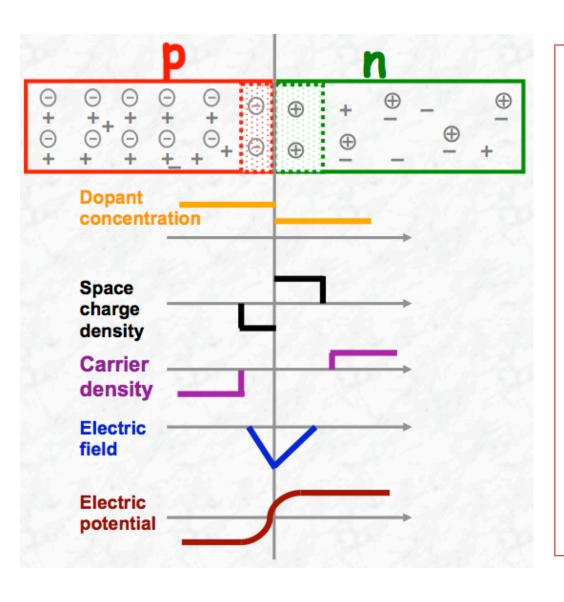
- Electron
- Positive ion from removal of electron in n-type impurity
- Negative ion from filling in p-type vacancy

Hole

## DEPLETION ZONE in SILICON DETECTOR



## p-n Junction



Diffusion of e<sup>-</sup> from n-side and h<sup>+</sup> from p-side.

Recombination on the other side, free charges disappear around junction: *depletion*.

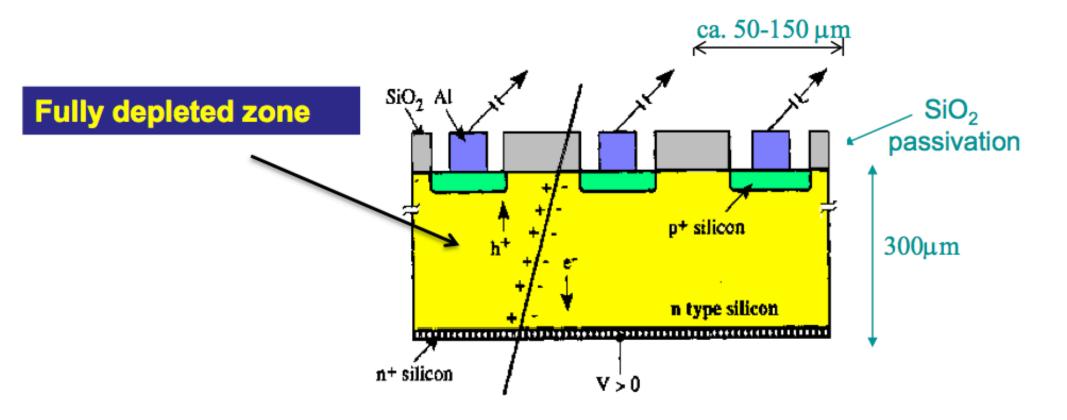
Neutral p- or n-Si becomes charged

→ E-field.

External field can increase or decrease depletion zone.

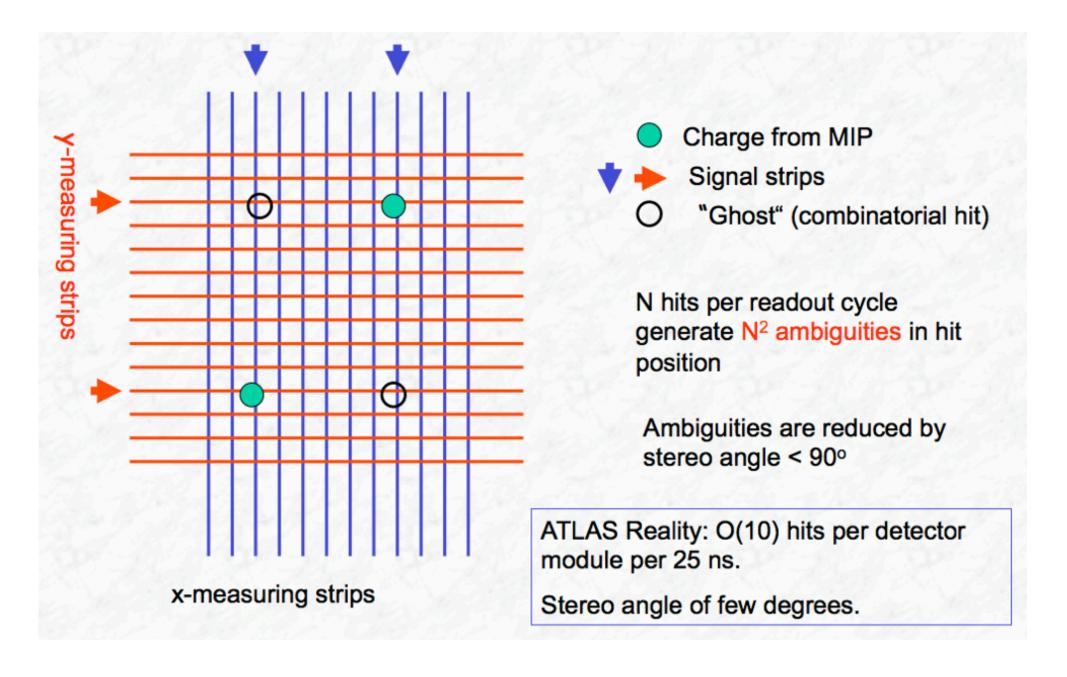
Depletion is what we want for detectors.

#### Silicon detector



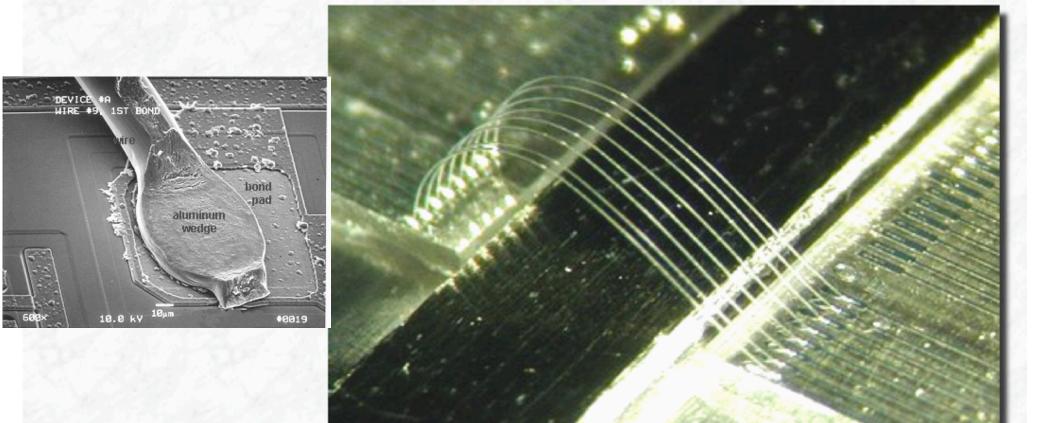
N (e-h) = 11 000/100 $\mu$ m Position Resolution down to ~ 5 $\mu$ m !

## ANGLE BETWEEN TWO SI-DETECTORS

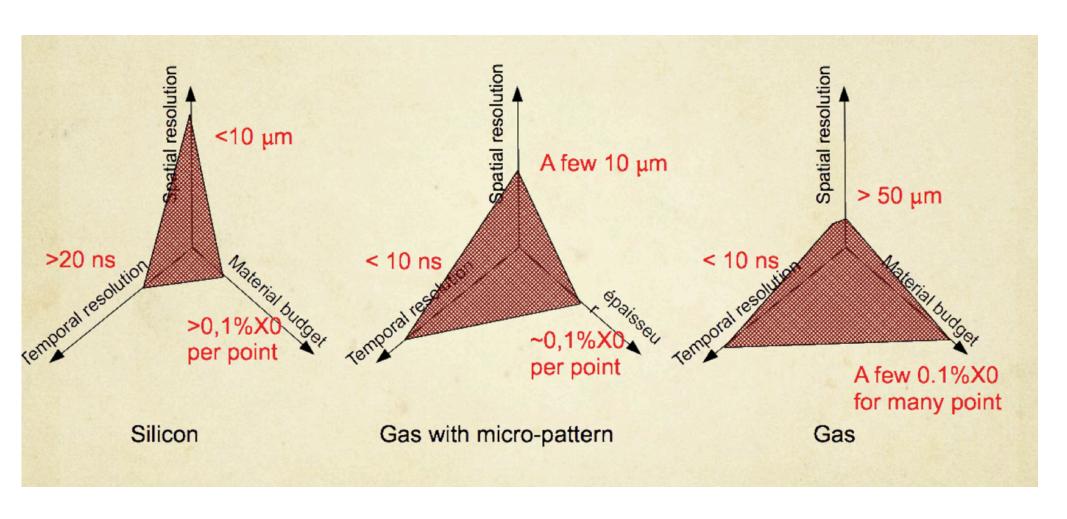


## WIRE BOUNDING

- Si detector needs connection to readout electronics
- High connection density with O(15) wires per mm
- Ultra-sonic bonding of ~20µm wires with semiautomatic system



## TENTATIVE COMPARISON



#### SUMMARY SILICON DETECTORS

Solid state detectors provide very high precision tracking in particle physics experiments (down to 5  $\mu$ m) for vertex measurement but also for momentum spectroscopy over large areas (ATLAS, CMS)

Thechnology is improving rapidly due to rapid Silicon development for electronics industry.

Silicon tracking detectors

Radiation hardness: detectors start to strongly degrade after 10<sup>14</sup>-10<sup>15</sup> hadrons/cm<sup>2</sup>.

#### Developments

Monolithic solid state detectors are the ultimate goal. Ongoing developments (CMOS) but radiation hardness is an issue.

### RESOLUTIONS TRACKING DETECTORS

Detector Type	Accuracy (rms)	Resolution Time	Dead Time
Bubble chamber	$10 – 150 \ \mu {\rm m}$	$1 \mathrm{\ ms}$	$50 \text{ ms}^a$
Streamer chamber	$300~\mu\mathrm{m}$	$2 \mu s$	$100~\mathrm{ms}$
Proportional chamber	$50-300 \ \mu \text{m}^{b,c,d}$	2 ns	200  ns
Drift chamber	50–300 $\mu\mathrm{m}$	$2 \text{ ns}^e$	100  ns
Scintillator	_	$100 \text{ ps/n}^f$	10  ns
Emulsion	$1~\mu\mathrm{m}$	_	_
Liquid Argon Drift [Ref. 6]	${\sim}175450~\mu\mathrm{m}$	$\sim 200~\mathrm{ns}$	$\sim 2~\mu \mathrm{s}$
Gas Micro Strip [Ref. 7]	$3040~\mu\mathrm{m}$	< 10  ns	_
Resistive Plate chamber [Ref. 8]	$\lesssim 10 \ \mu \mathrm{m}$	1-2  ns	_
Silicon strip	pitch/ $(3 \text{ to } 7)^g$	h	h
Silicon pixel	$2~\mu\mathrm{m}^i$	h	h

<sup>&</sup>lt;sup>a</sup> Multiple pulsing time.

 $<sup>^</sup>b$  300  $\mu \mathrm{m}$  is for 1 mm pitch.

 $<sup>^</sup>c$  Delay line cathode readout can give  $\pm 150~\mu\mathrm{m}$  parallel to a node wire.

d wirespacing/ $\sqrt{12}$ .

e For two chambers.

f n = index of refraction.

 $<sup>^</sup>g$  The highest resolution ("7") is obtained for small-pitch detectors ( $\lesssim\!25~\mu\mathrm{m})$  with pulse-height-weighted center finding.

 $<sup>^</sup>h$  Limited by the readout electronics [9]. (Time resolution of  $\leq 25$  ns is planned for the ATLAS SCT.)

 $<sup>^</sup>i$  Analog readout of 34  $\mu \mathrm{m}$  pitch, monolithic pixel detectors.

#### SOME MOTIVATIONS and EXAMPLES

#### Motivation:

b-Quark tagging & life time measurements via secondary vertex finding ...

e.g.: 
$$p \bar{p} \to t \bar{t} + X$$
 [Tevatron]  $\hookrightarrow b \bar{b} W^+ W^-$ 

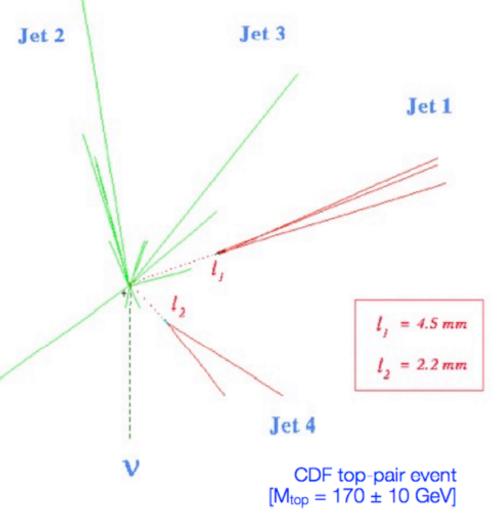
$$pp \rightarrow H + X \hspace{1cm} ext{[LHC]} \ \hookrightarrow b ar{b}$$

Typical lifetime:  $\tau = 10^{-12} .... 10^{-13} s$ 

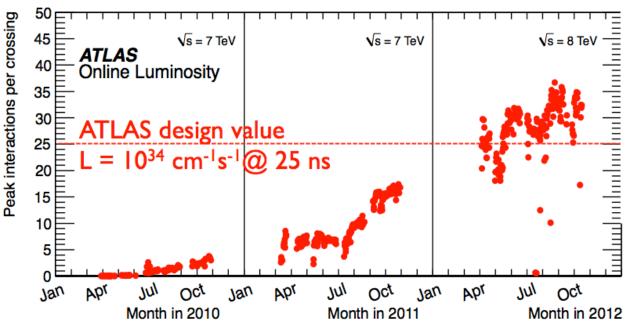
$$\gamma c\tau = \gamma \cdot 3.10^{10} \text{ cm/s} \cdot 10^{-13} \text{ s}$$
  
=  $\gamma \cdot 30 \text{ } \mu \text{m}$ 

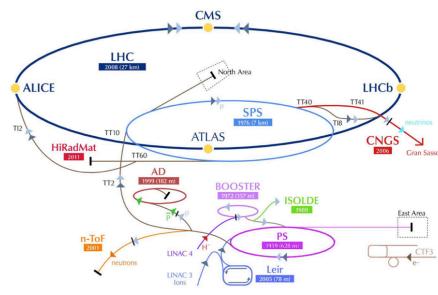
Thus:

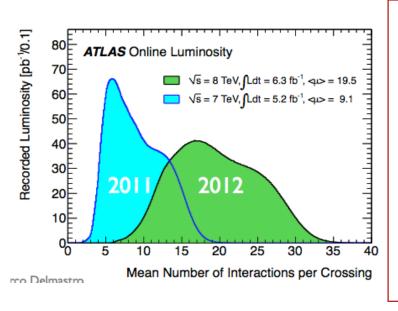
To measure lifetime in picosecond regime one needs spacial resolution of the order of 5 - 30  $\mu$ m ...



## INTERLUDE: PILE-UP at LHC







With ~10<sup>11</sup> protons/bunch, multiple pp collisions when the two proton beams cross at the interaction points.

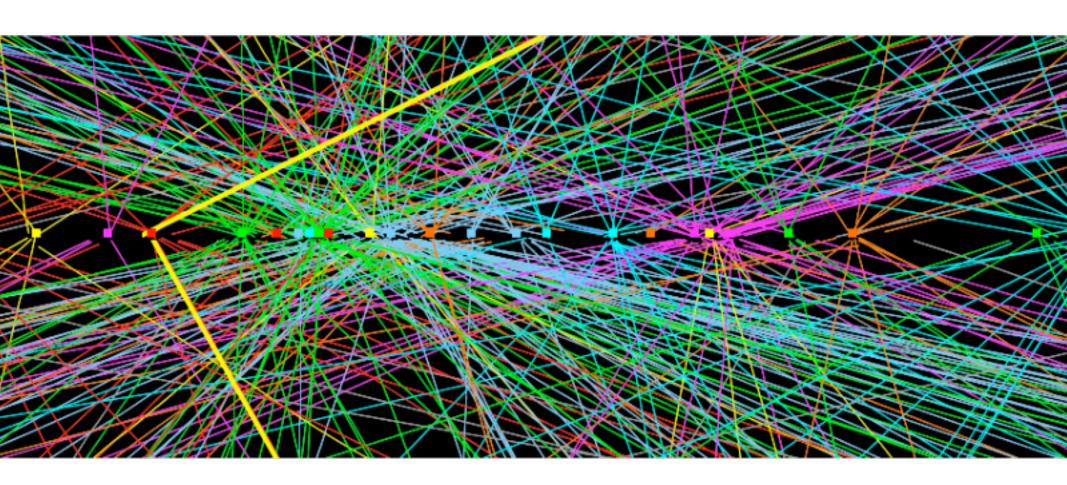
In 2010-2012, LHC run with  $\Delta \tau$ =50 ns between two bunches, pile-up was already as high as expected the LHC nominal luminosity.

Trigger must be pile-up resilient

Reconstruction & optimisation has to be optimised

Precise modelling of in-time/out-of-time pileup in MC

### **MOTIVATIONS** and **EXAMPLES**



pp collisions in ATLAS at √s=8 TeV (with β\*=0.6 m) Z→μμ event with 25 pile-up events

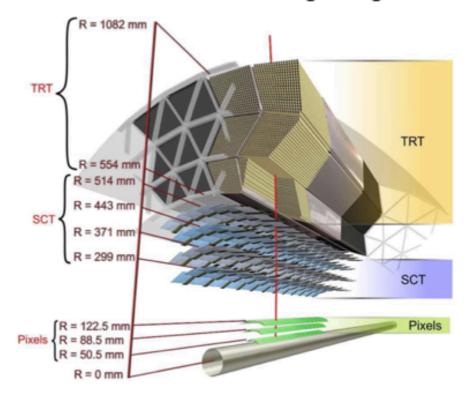
**TABLE 4** Main parameters of the ATLAS and CMS tracking systems (see Table 6 for details of the pixel systems)

Parameter	ATLAS	CMS
Dimensions (cm) -radius of outermost measurement -radius of innermost measurement -total active length	101–107 5.0 560	107–110 4.4 540
Magnetic field B (T) BR <sup>2</sup> (T·m <sup>2</sup> )	2 2.0 to 2.3	4 4.6 to 4.8
Total power on detector (kW)	70	60
Total weight in tracker volume (kg)	≈4500	≈3700
Total material $(X/X_0)$ -at $\eta \approx 0$ (minimum material) -at $\eta \approx 1.7$ (maximum material) -at $\eta \approx 2.5$ (edge of acceptance)	0.3 1.2 0.5	0.4 1.5 0.8
Total material ( $\lambda/\lambda_0$ at max)	0.35	0.42
Silicon microstrip detectors -number of hits per track -radius of innermost meas. (cm) -total active area of silicon (m <sup>2</sup> ) -wafer thickness (microns) -total number of channels -cell size ( $\mu$ m in $R\phi \times cm$ in z/R) -cell size ( $\mu$ m in $R\phi \times cm$ in z/R)	$8$ $30$ $60$ $280$ $6.2 \times 10^{6}$ $80 \times 12$	$14$ $20$ $200$ $320/500$ $9.6 \times 10^6$ $80/120 \times 10$ and $120/180 \times 25$
Straw drift tubes (ATLAS only) -number of hits per track ( $ \eta  < 1.8$ ) -total number of channels -cell size (mm in $R\phi \times cm$ in z)	35 350,000 4 × 70 (barrel) 4 × 40 (end caps)	

### INNER TRACKING SYSTEMS

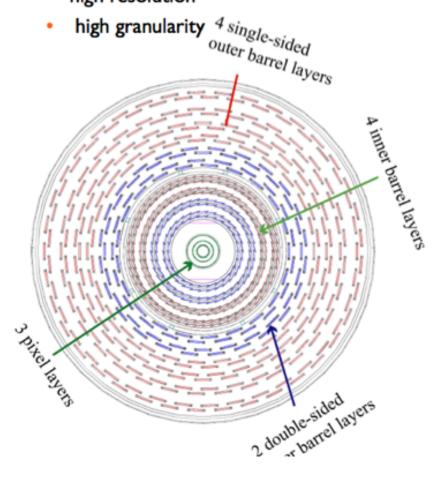
#### ATLAS

- ✓ Solenoidal field: 2 T
- ✓ Silicon (strips and pixels) + TRT
  - high granularity and resolution close to interaction region
  - "continuous" tracking at large radii

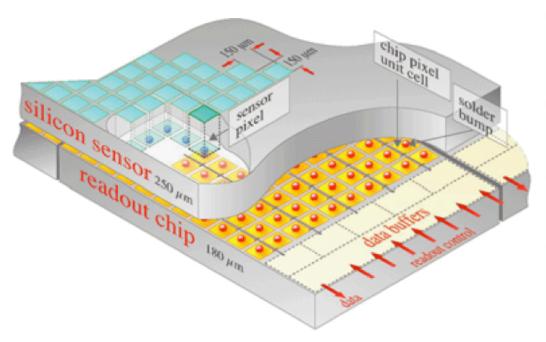


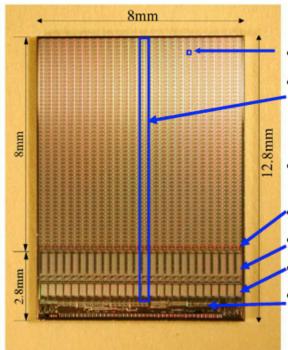
#### CMS

- ✓ Solenoidal filed: 4 T
- ✓ Full silicon strip and pixel detectors
  - high resolution



# TRACKING DETECTORS: CMS pixel module

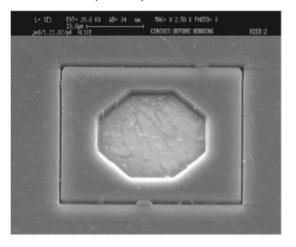


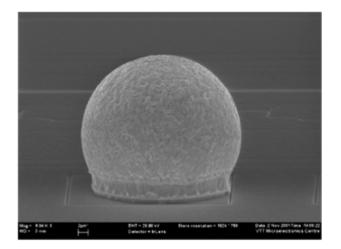


#### PSI43

- 150 μm x 150 μm pixel
- 52x53 pixels in 26 double columns 345 k transistors
- Periphery:
   78 k transistors
- Pixel-column interface
- Data buffers (4x24 capacitors)
- Timestamp buffers (8x8 bits)
- I2C, DACs, regulators, counters, readout, wirebonds 6 k transistors

10 µm ←



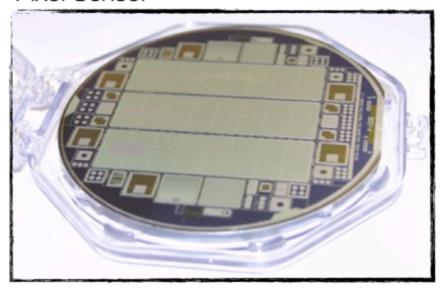


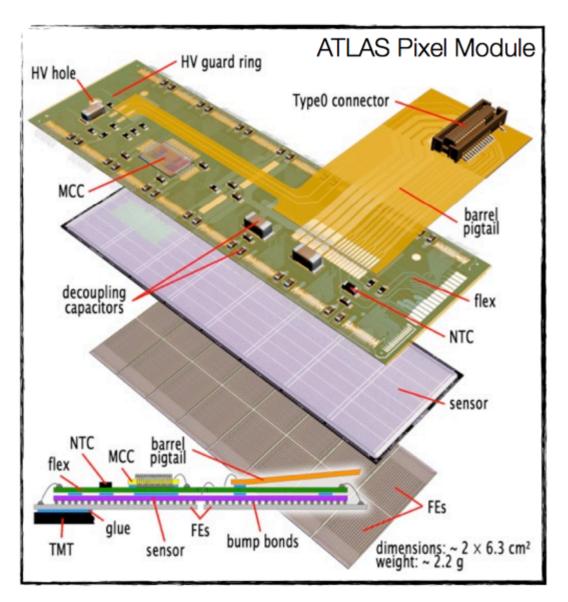
# TRACKING DETECTORs: ATLAS pixel module

ATLAS Pixel Detector

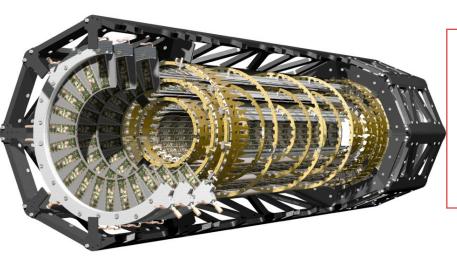
[Details]

#### Pixel Sensor





#### ATLAS PIXEL DETECTOR



1744 pixel modules with 46080 pixels/module

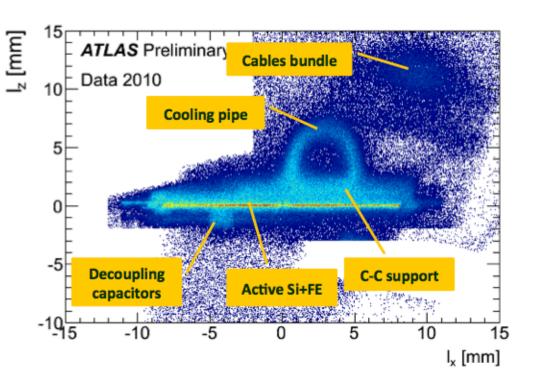
Each chip:  $50x400 \ \mu m^2 \Longrightarrow \sigma_{pos} = 14/115 \ \mu m$ 

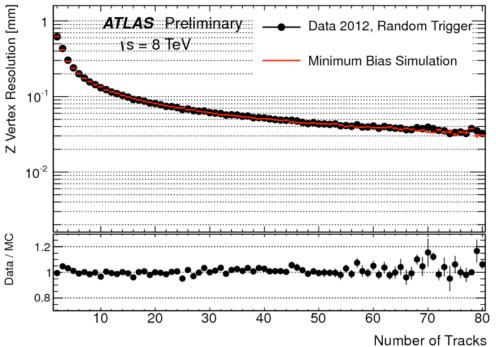
**Barrel** R=50.5, 88.5 & 122.5 mm

+ ONE NEW LAYER (IBL) at R=30 mm installed this summer

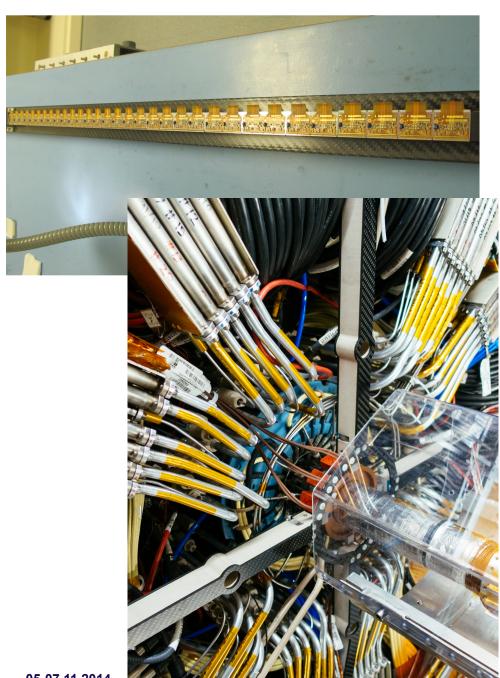
EndCap R coverage 9-15 cm

Installation 27 June 2007 LHC beam circulated in September 2008





# ATLAS NEW PIXEL LAYER R=3.3 cm - IBL





6 M pixels at R=3.3 cm Improved light quard rejection

#### ATLAS SILICON STRIPS DETECTOR

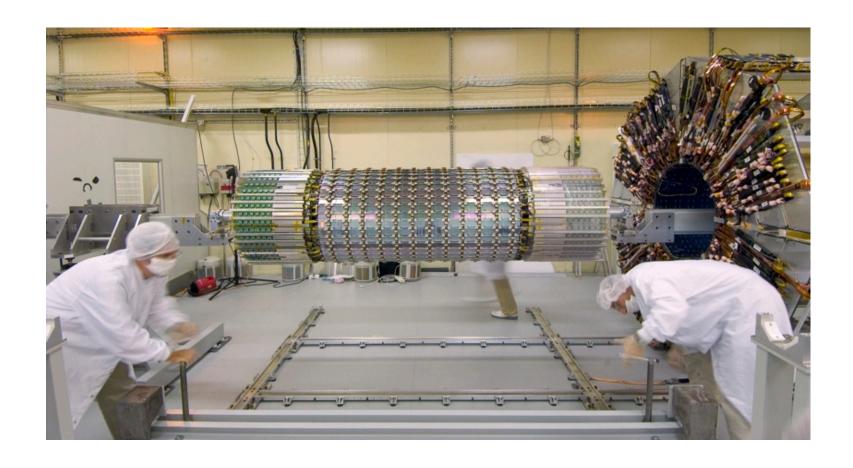
**Barrel** 4 cylinders at R=300, 373, 447 & 520 mm (r-φ & z precision coordinates)

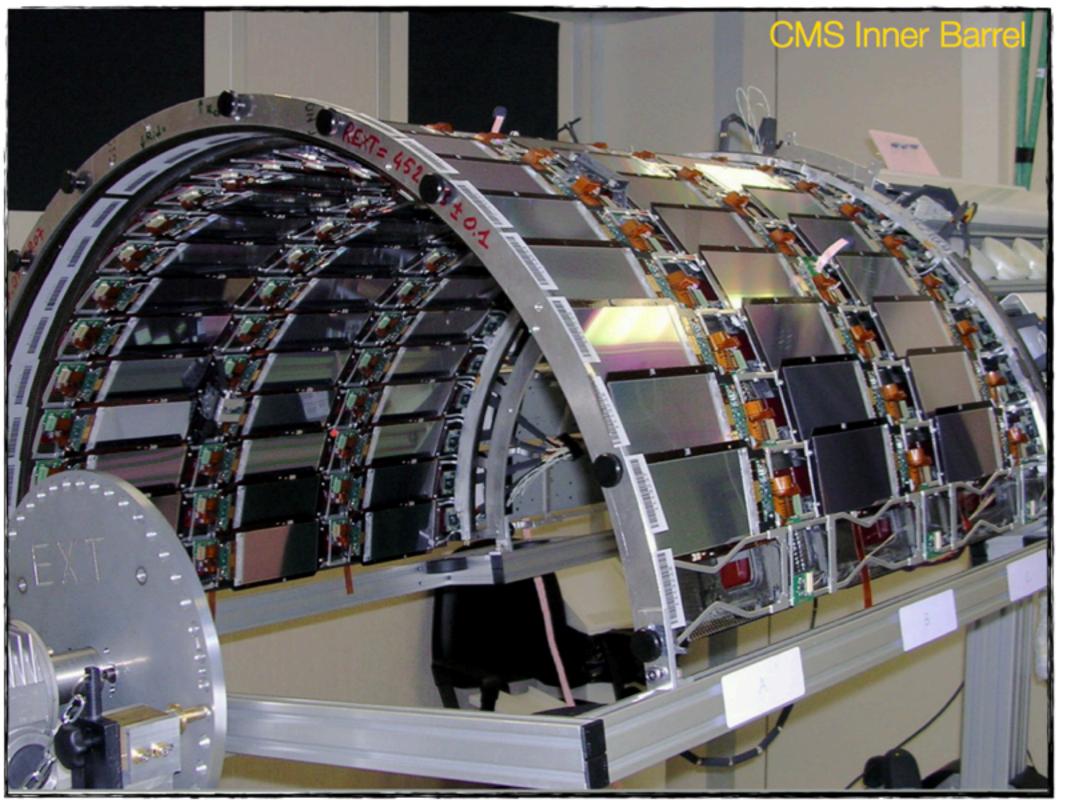
Endcap 9 disks on each side

~4000 modules

Each strip has 80  $\mu$ m pitch  $\Longrightarrow \sigma_{pos} = 23 \mu$ m

8 points per track



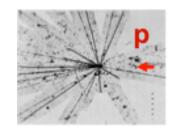


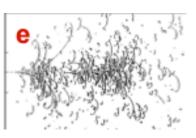
#### MAIN PERFORMANCE OF TRACKING SYSTEMS

	ATLAS	CMS
Reconstruction efficiency for muons with $p_T = 1 \text{ GeV}$	96.8%	97.0%
Reconstruction efficiency for pions with $p_T = 1 \text{ GeV}$	84.0%	80.0%
Reconstruction efficiency for electrons with $p_T = 5 \text{ GeV}$	90.0%	85.0%
Momentum resolution at $p_T = 1 \text{ GeV}$ and $\eta \approx 0$	1.3%	0.7%
Momentum resolution at $p_T = 1 \text{ GeV}$ and $\eta \approx 2.5$	2.0%	2.0%
Momentum resolution at $p_T = 100 \text{ GeV}$ and $\eta \approx 0$	3.8%	1.5%
Momentum resolution at $p_T = 100 \text{ GeV}$ and $\eta \approx 2.5$	11%	7%
Transverse i.p. resolution at $p_T = 1 \text{ GeV}$ and $\eta \approx 0 (\mu\text{m})$	75	90
Transverse i.p. resolution at $p_T = 1 \text{ GeV}$ and $\eta \approx 2.5 \; (\mu\text{m})$	200	220
Transverse i.p. resolution at $p_T = 1000 \text{ GeV}$ and $\eta \approx 0 (\mu\text{m})$	11	9
Transverse i.p. resolution at $p_T = 1000$ GeV and $\eta \approx 2.5$ (µm)	11	11
Longitudinal i.p. resolution at $p_T = 1$ GeV and $\eta \approx 0$ ( $\mu$ m)	150	125
Longitudinal i.p. resolution at $p_T = 1$ GeV and $\eta \approx 2.5$ (µm)	900	1060

- Momentum resolution on average superior in CMS
- Similar vertexing and b-tagging performances are similar
- Impact of material and B-field already visible on efficiencies

1. Particles interact with matter depends on particle and material



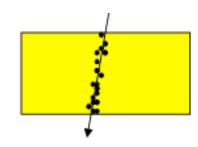


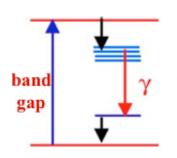
2. Energy loss transfer to detectable signal depends on the material

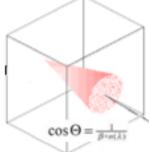
Detecting emitted light

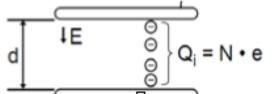
Detecting ionisation current

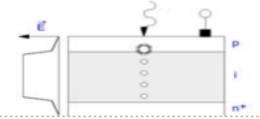
3. Signal collection depends on signal and type of detection











4. BUILD a SYSTEM

depends on physics, experimental conditions,....



## **CREDIT and BIBLIOGRAPHY**

#### A lot of material in these lectures are from:

Daniel Fournier @ EDIT2011

Marco Delmastro @ ESIPAP 2014

Weiner Raigler @ AEPSHEP2013

Hans Christian Schultz-Coulon's lectures

Carsten Niebuhr's lectures [1][2][3]

Georg Streinbrueck's lecture

Pippa Wells @ EDIT2011

Jérôme Baudot @ ESIPAP2014